# Fully integrated octal valve controller system on chip

The SB0800 device is a valves and pump controller system designed for use in harsh industrial environments.

It has eight high-current low-side drivers for use with solenoid valves, and high-side gate drivers for use with controlling two external N-channel MOSFETs, for DC motor and a master relay for solenoid coils. Alongside this, the SB0800 has three analog to digital converters, plus a low-side driver allowing drive resistive charges. The SB0800 boosts an internal charge pump, permitting the high-side drivers to use inexpensive N-channel MOSFETs. The digital I/O pins can be configured for both 5.0 V and 3.3 V levels for easy connection to any microprocessor. The SB0800 uses standard SPI protocol communication.

The SB0800 is a perfect solution for hydraulic and pneumatic applications. This device is powered by SMARTMOS technology.

#### **Features**

- · Operating voltage 6.0 V to 36 V
- · Eight valves control
  - Four current regulated valves up to 2.25 A (5.0 kHz)
  - Four PWMed valves up to 5.0 A (5.0 kHz)
- · High-side predriver for valves protection
- Pump motor predriver up to 500 Hz PWM
- · 16-bit SPI interface with watchdog
- · Three 10-bit ADC channels
- High-side driver for general purpose (R<sub>DS(on)</sub> 1.0 Ω)
- Low-side driver for resistive charge ( $R_{DS(on)}$  14.0  $\Omega$ )
- · Die temperature warning
- · Supervision

### **SB0800**

#### INDUSTRIAL CONTROLLER CHIP



AE SUFFIX (PB-FREE) 98ASA10763D 64-PIN LQFP-EP

#### **Applications**

Industrial Controller

- Spot Welding
- Fluid Coating
- Temperature Control
- Brake Pressure
- · Laser Cutting
- · Bottle Moulding
- Filling Pressure
- 3D Printer
- Oxygen Concentrator
- · Medical test equipment

- · Dialysis machines
- · Blood pressure
- · Soda dispensers
- Heavy equipment and construction machinery
- · Fork lifts
- Water control system for irrigation (connected to farm tractor)
- Food control in animal farm

### MC34SB0800

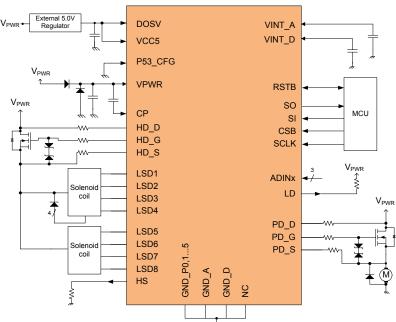


Figure 1. SB0800 simplified 5.0 V application diagram



<sup>\*</sup> This document contains certain information on a new product. Specifications and information herein are subject to change without notice. © 2016 NXP B.V.

# 1 Orderable parts

This section describes the part numbers available to be purchased along with their differences. Valid orderable part numbers are provided on the web. To determine the orderable part numbers for this device, go to <a href="http://www.nxp.com">http://www.nxp.com</a> and perform a part number search for the following device numbers.

Table 1. Orderable part variations

Part number	Temperature (T <sub>A</sub> )	Package	Description	Notes
34SB0800 octal valves and pur	np controller system on chi	p for industrial		
MC34SB0800AE	-40 °C to 125 °C	10 x 10, 64 LQFP-EP	<ul> <li>Four PWMed valve controls and four current regulated valve controls</li> <li>Safe switch control</li> <li>Pump motor control up to 500 Hz</li> <li>High-side driver for general purpose</li> <li>Low-side FET for resistive loads</li> </ul>	(1)

#### Notes

1. To order parts in Tape & Reel, add the R2 suffix to the part number.

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# 2 Internal block diagram

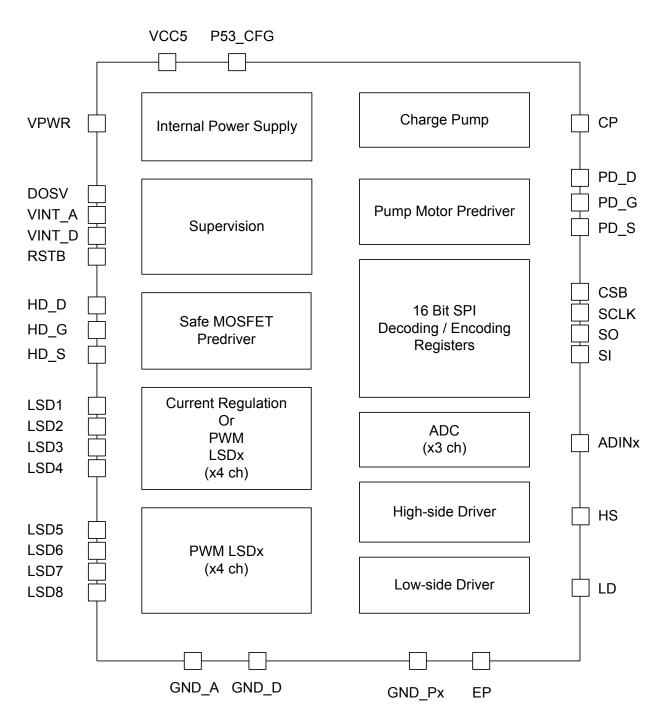


Figure 2. SB0800 simplified internal block diagram

# 3 Pin connections

# 3.1 Pinout diagram

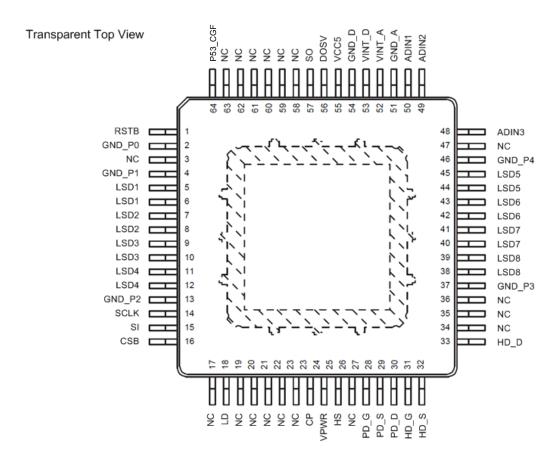


Figure 3. SB0800 64-pin LQFP-EP pinout diagram

# 3.2 Pin definitions

Table 2. SB0800 pin definitions

Pin number	Pin name	Pin function	Definition	DOSV = 5.0 V	DOSV = 3.3 V	Notes
1	RSTB	Reset	Reset PIN	externa	pull-up	
2	GND_P0	Supply	Power Ground 0 <sup>(4)</sup>	no	no	
4	GND_P1	Supply	Power Ground 1	no	no	(4)
5, 6	LSD1	Low-side Driver for Current Regulated & PWMed Valves	Open Drain Output for Low-side Driver 1	no	no	(2)
7, 8	LSD2	Low-side Driver for Current Regulated & PWMed Valves	Open Drain Output for Low-side Driver 2	no	no	(2)
9, 10	LSD3	Low-side Driver for Current Regulated & PWMed Valves	Open Drain Output for Low-side Driver 3	no	no	(2)
11, 12	LSD4	Low-side Driver for Current Regulated & PWMed Valves	Open Drain Output for Low-side Driver 4	no	no	(2)
13	GND_P2	Supply	Power Ground 2	no	no	(4)
14	SCLK	SPI	SPI Interface Clock Input	no	no	
15	SI	SPI	SPI Interface Digital Input	no	no	
16	CSB	SPI	SPI Interface Chip Interface	no	no	
18	LD	Low-side Driver	Open Drain Output for Low-side	no	no	
24	СР	Charge Pump	Charge Pump Output. For internal use, connect a storage capacitor of > 68 nF to VPWR.	no	no	
25	VPWR	Supply	Supply PIN connect to battery through reverse diode	no	no	
26	HS	High-side Driver for General Purpose (optional)	High-side driver for general purpose	no	no	
28	PD_G	Motor Pump Driver	Gate Output to Control Pump Motor FET Connect to gate of external pump motor FET	no	no	
29	PD_S	Motor Pump Driver	Source Feedback Pump Motor FET Connect to source of external pump motor FET	no	no	
30	PD_D	Motor Pump Driver	Drain Feedback Pump Motor FET Connect to drain of external pump motor FET	no	no	
31	HD_G	High-side Driver for Valve's Fail-safe FET	Gate Output to Control High-side FET Connect to gate of external pump motor FET	no	no	
32	HD_S	High-side Driver for Valve's Fail-safe FET	Source Feedback High-side FET Connect to source of external High-side FET	no	no	
33	HD_D	High-side Driver for Valve's Fail-safe FET	Drain Feedback High-side FET Connect to drain of external High-side FET	no	no	
37	GND_P3	Supply	Power Ground 3	no	no	(4)
38, 39 <sup>(2)</sup>	LSD8	Low-side Driver for PWMed Valves	Open Drain Output for Low-side Driver 8 no no		no	
40, 41 (2)	LSD7	Low-side Driver for PWMed Valves	Open Drain Output for Low-side Driver 7	no no		
42, 43 <sup>(2)</sup>	LSD6	Low-side Driver for PWMed Valves	Open Drain Output for Low-side Driver 6	no	no	
44, 45 <sup>(2)</sup>	LSD5	Low-side Driver for PWMed Valves	Open Drain Output for Low-side Driver 5			
46	GND_P4	Supply	Power Ground 4			(4)
48	ADIN3	ADC	Anadam ta Dinital Insurt 0		no	(+)
70	ADINO			no	110	

Table 2. SB0800 pin definitions (continued)

Pin number	Pin name	Pin function	Definition	DOSV = 5.0 V	DOSV = 3.3 V	Notes
49	ADIN2	ADC	Analog to Digital Input 2	no	no	
50	ADIN1	ADC	Analog to Digital Input 1	no	no	
51	GND_A	Supply	Analog Ground	no	no	
52	VINT_A	Internal Function	2.5 V internal supply for analog	no	no	(2)
53	VINT_D	Internal Function	2.5 V internal supply for digital	no	no	(2)
54	GND_D	Supply	Digital Ground	no	no	
55	VCC5	Supply	5.0 V Supply PIN	5V	5V	
56	DOSV	Supply	Digital Output Voltage Supply, DOSV under voltage reset	5V	3.3V	
57	SO	SPI	SPI Interface Digital Output	DOSV	/ bias	
64	P53_CFG	Supply	Input to select output voltage at DOSV (5.0 V/ 3.3 V)	no	no	
20, 21, 22, 23, 58, 59, 60, 61, 62	NC	Not connected	Pin used for production tests and must not be grounded	no	no	
3, 17, 19, 27, 34, 35, 36, 47, 63	NC	Not connected	Pin used for production tests and must be grounded	no	no	
Exposed pad	GND_P5	Supply	Power Ground 5	no	no	(4)

#### Notes

- 2. Pins must be shorted together
- 3. 220 nF/10 V capacitor needed
- 4. All GND\_Px pins must be shorted together at the PCB level.

# 4 General product characteristics

# 4.1 Maximum ratings

Table 3. Maximum ratings

Voltage parameters are absolute voltages referenced to GND\_A, GND\_D and flag (tied together internally). Exceeding these ratings may cause a malfunction or permanent damage to the device.

Symbol	Description (rating)	Min.	Max.	Unit	Notes
Supply		•			1
V <sub>VPWR</sub>	Analog Power supply voltage	-0.3	40	V	
V <sub>DOSV</sub>	Digital Output Supply Voltage	-0.3	7.0	V	
V <sub>P53_CFG</sub>	Selection of 5.0 V or 3.3 V for the digital	-0.3	7.0	V	
V <sub>VCC5</sub>	Digital power supply voltage	-0.3	7.0	V	
V <sub>GND_A</sub>	Ground analog	-0.3	0.3	V	
V <sub>GND_D</sub>	Ground digital	-0.3	0.3	V	
V <sub>GND_P</sub>	Ground exposed pad	-0.3	0.3	V	
Internal function	1	•			
V <sub>VINT_A</sub>	Internal regulator analog power supply	-0.3	3.0	V	
V <sub>VINT_D</sub>	Internal regulator digital power supply	-0.3	3.0	V	
Charge pump					•
V <sub>CP</sub>	Internal charge pump	-0.3 or V <sub>PWR</sub> -0.3	V <sub>PWR</sub> +15	V	
High-side driver	r for general purpose	•			•
V <sub>HS</sub>	High-side driver	-0.3	40 or V <sub>PWR</sub> +0.3	V	
High-side driver	r for valve's fail-safe FET				•
V <sub>HD_G</sub>	Gate of the high-side predriver	-20	55	V	
V <sub>HD_S</sub>	Source of the high-side predriver	-0.3	40	V	
V <sub>HD_D</sub>	Drain of the high-side predriver	-0.3	40	V	
Motor pump dri	ver				
V <sub>PD_G</sub>	Gate of the Motor Pump predriver	-0.3	55	V	
V <sub>PD_S</sub>	Source of the Motor Pump predriver	-0.3	40	V	
V <sub>PD_D</sub>	Drain of the Motor Pump predriver	-0.3	40	V	
Reset		•	- '		
V <sub>RSTB</sub>	Reset pin	-0.3	7.0	V	
A to D converte	r	•			
V <sub>ADINx</sub>	Input analog to digital	-0.3	7.0	V	

#### Table 3. Maximum ratings (continued)

Voltage parameters are absolute voltages referenced to GND\_A, GND\_D and flag (tied together internally). Exceeding these ratings may cause a malfunction or permanent damage to the device.

Symbol	Description (rating)	Min.	Max.	Unit	Notes
1		1			
V <sub>SO</sub>	Serial peripheral interface slave output	-0.3	DOSV +0.3	V	
V <sub>SI</sub>	Serial peripheral interface slave input	-0.3	7.0	V	
V <sub>CSB</sub>	Serial peripheral interface chip select	-0.3	7.0	V	
V <sub>SCLK</sub>	Serial peripheral interface clock	-0.3	7.0	V	
w-side driver	for valves (LSD1-8)	<u> </u>	<u>'</u>		
$V_{LSDx}$	Low-side driver for valves	<u>Table</u>	active clamp		
w-side driver		<u>.</u>			•
$V_{LD}$	Low-side driver	-100 mA	40	V	
ergy capabilit	у	•			•
E <sub>LSD1—4</sub>	Energy capability (EAR) at 125 °C • LSD1—4, with 20 mH load	_	30	mJ	
E <sub>LSD5—8</sub>	Energy capability (EAR) at 125 °C • LSD5—8, with 20 mH load	_	40	mJ	
E <sub>HS</sub>	Energy capability (EAR) at 125 °C • HS, with 20 mH load	_	13	mJ	
rrents		<b>.</b>	1		· I
I <sub>LSDX(POS)</sub>	Drain continuous current; during on state • LSDx	_	5.0	А	
I <sub>LSDX(NEG)</sub>	Maximum negative current for 5.0 ms without being destroyed • LSDx	-6.0	_	Α	
I <sub>DIG</sub>	Input current • P53_CFG, SI, CSB, SCLK, RSTB	-20	20	mA	

# 4.2 Operating conditions

This section describes the operating conditions and the current consumptions. Conditions apply to all the following data, unless otherwise noted.

#### Table 4. Operating conditions

Voltage parameters are absolute voltages referenced to GND. Exceeding these ratings may cause a malfunction or permanent damage to the device.

Symbol	Description (rating)	Min.	Тур.	Max.	Unit	Notes
V <sub>PWR</sub>	Functional operating supply voltage. Device is fully functional.  • All features are operating	6.0	_	36	V	
V <sub>CC5</sub>	Functional operating supply voltage. Device is fully functional.  • All features are operating.	4.75	_	5.25	V	
V <sub>DOSV</sub>	Functional operating supply voltage. Device is fully functional.  • All features are operating.	3.13	_	5.25	V	

SB0800

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# 4.3 Supply currents

This section describes the operating conditions and the current consumptions. Conditions apply to all the following data, unless otherwise noted.

#### Table 5. Supply currents

Characteristics noted under conditions 6.0 V  $\leq$  V<sub>PWR</sub>  $\leq$  36 V, 4.75 V  $\leq$  V<sub>CC5</sub>  $\leq$  5.25 V, 3.13 V  $\leq$  V<sub>DOSV</sub>  $\leq$  5.25 V, -40 °C  $\leq$  T<sub>J</sub>  $\leq$  125 °C, GND = 0 V, unless otherwise noted. Typical values noted reflect the approximate parameter means at T<sub>A</sub> = 25 °C under nominal conditions, unless otherwise noted.

Symbol	Description (rating)	Min.	Тур.	Max.	Unit	Notes
VPWR current consumptions			+	1	1	
I <sub>QVPWR</sub>	Quiescent current of VPWR measured at 36 V, V <sub>CC5</sub> = 0 V	_	_	30	μΑ	
I <sub>VPWR</sub>	Current of VPWR in operating mode, V <sub>CC5</sub> = 5.0 V	_	20	_	mA	
VCC5 current co	nsumptions		•			
I <sub>VCC5</sub>	Current of VCC5 pin in operating mode (SPI frequency at 10 MHz)	_	10	_	mA	
DOSV current consumptions						
I <sub>DOSV</sub>	Current of DOSV pin in operating mode (SPI frequency at 10 MHz)	_	_	10	mA	

# 4.4 Thermal ratings

#### Table 6. Thermal data

Symbol	Description (rating)	Min.	Тур.	Max.	Unit	Notes
TJ	Operational junction Temperature	-40	_	150	°C	
T <sub>STG</sub>	Storage Temperature	-65	_	150	°C	
R <sub>θJC</sub>	R0JC, Thermal Resistance, Junction to Case (Package exposed pad) - Steady state	_	_	2.0	°C/W	
T <sub>PPRT</sub>	Peak Package Reflow Temperature During Reflow	_	_	Note 7	°C	(5)(6)

#### Notes

- 5. Lead soldering temperature limit is for 10 seconds maximum duration. Lead soldering can be done twice. Device must be delivered in dry pack.
- 6. NXP's Package Reflow capability meets Pb-free requirements for JEDEC standard J-STD-020C. For Peak Package Reflow Temperature and Moisture Sensitivity Levels (MSL), Go to www.nxp.com, search by part number [e.g. remove prefixes/suffixes and enter the core ID to view all orderable parts. (i.e. MC33xxxD enter 33xxx), and review parametrics.

# 4.5 Logical inputs and outputs

### Table 7. Logical inputs/outputs

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to 125 °C, unless otherwise specified.

Symbol	Description (rating)	Min.	Max.	Unit	Notes
ogical inputs					
$V_{IH\_X}$	Input High-voltage • P53_CFG, RSTB, SI, CSB, SCLK, ADIN1, ADIN2, ADIN3	_	2.0	V	
$V_{IL_{\_X}}$	Input Low-voltage • P53_CFG, RSTB, SI, CSB, SCLK, ADIN1, ADIN2, ADIN3	0.8	_	V	
ogical outputs		<u> </u>			
V <sub>OH_X</sub>	Input High-voltage, with 1.0 mA • SO	0.8 x DOSV	_	V	
$V_{OL\_X}$	Input Low-voltage, with 1.0 mA • SO	_	0.4	V	
VOL_ <sub>RSTB</sub>	RSTB Low-voltage, with 1.0 mA • RSTB	_	0.4	V	

# 5 General description

# 5.1 Block diagram

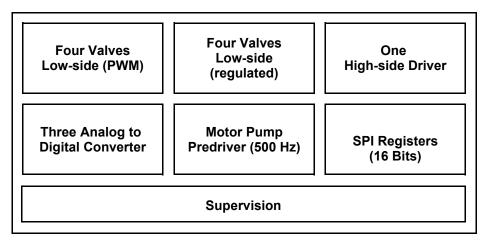


Figure 4. SB0800 functional block diagram

# 5.2 Functional description

The SB0800 device is a valves and pump controller, designed for use in harsh industrial environments, requiring few external components. The SB0800 eight high-current low-side drivers for use with solenoid valves, and high-side gate drivers for controlling two external N-channel MOSFETs for use with a pump motor and master relay for a solenoid coil. In conjunction with this primary functionality, the SB0800 has one low-side driver to control a resistive load. The SB0800 boosts an internal charge-pump, allowing the high-side drivers to use inexpensive N-channel MOSFETs. The digital I/O pins can be configured for both 5.0 V and 3.3 V levels for easy connection to any microprocessor. Also, the device integrated three Analog to Digital converters. The SB0800 uses standard SPI protocol for communication.

### 5.3 Features

This section presents the detailed features of SB0800.

Table 8. Device features set

Function	Description
High-side Driver for Fail-safe FET	High-side Fail-safe FET driver     Overcurrent shutdown     Load leakage detection
High-side Driver for general purpose	<ul> <li>High-side switch connected to VPWR (1.0 Ω max Rds(on) at 125 °C)</li> <li>Open load detection</li> <li>V<sub>DS</sub> state monitoring</li> <li>Overcurrent shutdown</li> <li>Overtemperature shutdown</li> </ul>
Pump Driver	<ul> <li>Pump motor driver up to 500 Hz PWM frequency controllable through SPI command or a digital signal</li> <li>Overcurrent shutdown between external FET drain and source</li> </ul>

Table 8. Device features set (continued)

Function	Description
Low-side solenoid driver (x4)	<ul> <li>Solenoid driver (300 mΩ max. R<sub>DS(on)</sub> at 125 °C) works either as current regulator or as PWM</li> <li>Current regulation deviation: ±2.0%</li> <li>Configurable PWM frequency from 3.0 kHz to 5.0 kHz</li> <li>PWM duty cycle 10-bit resolution</li> <li>Open load detection</li> <li>V<sub>DS</sub> state monitoring</li> <li>Overcurrent shutdown</li> <li>Overtemperature shutdown</li> <li>Send current regulation error flag (only for current regulation modules)</li> </ul>
Low-side solenoid driver (x4)	<ul> <li>Solenoid driver (225 mΩ max R<sub>DS(ON)</sub> at 125 °C) are PWM low-side driver</li> <li>Configurable PWM frequency from 3.0 kHz to 5.0 kHz</li> <li>PWM duty cycle resolution 0.39%</li> <li>Open load detection</li> <li>V<sub>DS</sub> state monitoring</li> <li>Overcurrent shutdown</li> <li>Overtemperature shutdown</li> <li>Max switch-off energy 40 mJ</li> </ul>
Low-side resistive Driver	<ul> <li>Low-side driver (20 mA max, R<sub>DS(on)</sub> 8.0 Ω)</li> <li>Open load detection</li> <li>V<sub>DS</sub> state monitoring</li> <li>Overcurrent shutdown</li> <li>Overtemperature shutdown</li> </ul>
Low-side Driver	<ul> <li>Low-side driver (350 mA max, R<sub>DS(on)</sub> 1.0 Ω)</li> <li>Open load detection</li> <li>V<sub>DS</sub> state monitoring</li> <li>Overcurrent shutdown</li> <li>Overtemperature shutdown</li> </ul>
Analog to Digital Converter (x3)	<ul> <li>10-bit ADC</li> <li>External ADINx pins</li> <li>Internal voltages and temperature information</li> <li>Allow to control the pump by a MCU</li> <li>Allow to control the low-side resistive driver by a MCU</li> </ul>
Supervision	VINT_x undervoltage (internal regulator) VCC5 & DOSV undervoltage (supply voltage from external) Watchdog fault ALU check counter overflow External reset fault VPWR undervoltage and overvoltage detections Mismatch MAIN-AUX OSC CLK Temperature warning SPI failure Charge pump issue GND supervision

# 6 Functional block description

# 6.1 Error handling

Table 9. Error handling

Type of error	Detection condition	Action	Clear SPI flag	Restart condition	Notes
High-side driver					•
Overcurrent between external FET Drain and Source	ON	HD_G Off + SPI fault flag (HD_oc)	Write 1 to HD_clr_flt 1	Write 1 to HD_clr_fit and then turn on by SPI command (hd_on)	
Load leakage	hd_on rise- edge (SPI bit)	Ignore hd_on rise-edge command + SPI fault flag (HD lkg)	Write 1 to HD_clr_flt	Write 1 to HD_clr_flt and then turn on by SPI command (hd_ on)	
Pump motor PWM driver					
Overcurrent between external FET Drain and Source	ON	PD_G Off+ SPI fault flag (PD_oc)	Write 1 to PD_clr_flt	Write 1 to PD_clr_flt and then turn-on by SPI command (pd on)	
LSDx				•	
Open Load	OFF	SPI flag only (LSDx_op)	Read diagnosis	No	
V <sub>DS</sub> state monitoring	ON/OFF	Read V <sub>DS</sub> state by SPI (vds_LSDx)	update with min filter time (T1) rise and fall edge	No	
Overcurrent	ON	OFF fault FET only + SPI fault flag (LSDx_oc)	Write 1 to LSD_clr_flt	Write 1 to LSD_clr_flt and turn on by SPI command (LSDx duty cycle or current set point)	
Overtemperature	ON	OFF fault FET only + SPI fault flag (LSDx_ot)	Write 1 to LSD_clr_flt	Write 1 to LSD_clr_flt and turn on by SPI command (LSDx duty cycle or current set point)	
Current regulation error (only for LSD1-4)	ON	Read SPI flag only (LSDx_crer)	Read diagnosis	No	
LDx			<u> </u>	-	
Open Load	OFF	SPI flag only (LDx_op)	Read diagnosis	No	
V <sub>DS</sub> state monitoring	ON/OFF	Send V <sub>DS</sub> state by SPI (V <sub>DS_LD</sub> )	update with min filter time (T1) rise and fall edge	No	
Overcurrent	ON	OFF fault FET only + SPI fault flag (LD_oc)	Write 1 to LD_clr_flt	Write 1 to LD_clr_flt and turn on by SPI command (LD_on)	
Overtemperature	ON	OFF fault FET only + SPI fault flag (LD_ot)	Write 1 to LD_clr_flt	Write 1 to LD_clr_flt and turn on by SPI command (LD_on)	
HS					
Open Load	OFF	SPI flag only (HS_ op)	Read diagnosis	No	
V <sub>DS</sub> state monitoring	ON/OFF	Send V <sub>DS</sub> state by SPI (V <sub>DS_HS</sub> )	update with min filter time	No	
Overcurrent	ON	OFF fault FET only + SPI fault flag (HS_oc)	Write 1 to HS_clr_flt	Write 1 to HS_clr_flt and then turn on by SPI command (HS_ on)	

Table 9. Error handling (continued)

Type of error	Detection condition	Action	Clear SPI flag	Restart condition	Notes
Overtemperature	ON	OFF fault FET only + SPI fault flag (HS_ot)	Write 1 to HS_clr_flt	Write 1 to HS_clr_flt and then turn on by SPI command (HS_on)	
Supervision	•				
VINT_x Undervoltage	All except Sleep mode	SPI register reset & Vint_uv go to High	Read Vint_uv bit	No	
VCC5 & DOSV Undervoltage	All except Sleep mode	SPI register reset except VCC5_uv go to High	Wait undervoltage reset filter time T1 (see <u>Table 19</u> )	See <u>Table 19</u> ,	
External reset fault	No internal RSTB pulldown	SPI registers go to initial state	Read the Message 0 of SPI register (see <u>Table 19</u> )	See <u>Table 19</u> ,	
VPWR Undervoltage	RSTB is high state	All LSDx Off (Clear all LSDx duty cycle registers or current set point) + SPI fault flag (V <sub>PWR_UV</sub> )	Normal condition     Read diagnosis (V <sub>PWR_UV</sub> )	Normal condition     Turn on by SPI command (LSDx duty cycle or current set point)	
VPWR Overvoltage	RSTB is in high state	All LSDx Off (Clear all LSDx duty cycle registers or current set point) + SPI fault flag (V <sub>PWR_OV</sub> )	Normal condition     Read diagnosis     (V <sub>PWR_OV</sub> )	Normal condition     Turn on by SPI command (LSDx duty cycle or current set point)	
Mismatch SB0800 MAIN-AUX OSC CLK	RSTB is in high state	SPI registers goes to initial state low except, see <u>Table 27</u>	Read RST_clk bit	No	
Temperature Warning	RSTB is in high state	SPI flag	Normal condition     Read diagnosis	No	
SPI Failure	RSTB is in high state	SPI flag (Fmsg)	Read diagnosis	No	
V <sub>PRE</sub> 10 Monitoring	RSTB is in high state	Send by SPI (ADC)	No	No	(9)
V <sub>PRE</sub> 12 Monitoring	RSTB is in high state	Send by SPI (ADC)	No	No	(9)
VINT_x Monitoring	RSTB is in high state	Send by SPI (ADC)	No	No	(9)
V <sub>cp_vpwr</sub> Monitoring	RSTB is in high state	Send by SPI (ADC)	No	No	
Temperature Monitoring	RSTB is in high state	Send by SPI (ADC)	No	No	(9)
GND_D Supervision	RSTB is in high state	SPI flag only (FGND)	No	No	
GND_A Supervision; indirect detection by VCC5 or DOSV	RSTB is in high state	SPI flag only (VCC5_UV or DOSV_UV)	No	No	

#### Notes

- 7. If xxx\_clr\_flt is written "1" by SPI, all SPI flags are set "0", so SW engineer has to read the SPI flag first and then write xxx\_clr\_flt to default value "0".
- 8. SW engineering can monitor internal supply voltage in real time with ADC reading, and can use fail-safe function. If these ADC results are not in a certain range, uC can reset the SB0800 (see ADC section).
- 9. Fail-safe switch off until power is off

# 6.2 High-side driver

# 6.2.1 Function description

The high-side driver is intended to control the fail-safe switch for the overall solenoid path, and HD\_G is controlled by the SPI command.

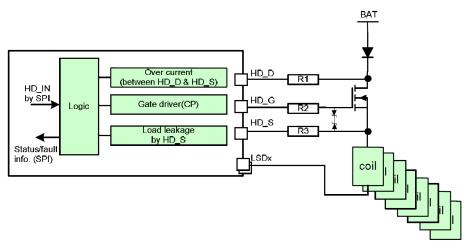


Figure 5. High-side driver

# 6.2.2 High-side driver and fault protection

### 6.2.2.1 Overcurrent

High-side driver protects the external n-channel power FET on HD\_G in overcurrent conditions. The drain-source voltage of the FET on HD\_G is checked if the high-side driver is switched on. If the measured drain-source voltage exceeds the overcurrent voltage threshold, the output of the overcurrent comparator is enabled. If the output of the comparator is active longer than the defined filter time, the output HD\_G is switched off. Overcurrent detection logic has a masking time from hd\_on turn-on against malfunctions on transient time. After switching off the power FET on HD\_G by an overcurrent condition, the power FET can be turned back to a "normal state" by a SPI write 1 to the "HD clr flt" register, and then turned on by a SPI command.

# 6.2.2.2 Load leakage detection

Each time HD\_G is turned on, the ILCdet current is sourced out of the HD\_S pin for the time t<sub>HD\_LC</sub>, to check the external leakage current on the node in the application. The high-side switch on HD\_G is turned on if the measured voltage is over the detection threshold. If this test fails, HD\_G does not turn-on and the fault flag is set to high. The power FET can be turned back to a "normal state" only by a SPI write 1 to the "HD\_clr\_flt" register, and then turned on by a SPI command. When the power FET is switched off, the gate capacitance of the FET is discharged by a constant current, which is controlled fast and slow by a SPI command (HPD\_sr).

# 6.2.2.3 External components of high-side driver

For protection, external resistors  $R_{HD\_D}$ ,  $R_{HD\_G}$ , and  $R_{HD\_S}$  are required (for example:  $R_{HD\_D} = 100 \Omega$ ,  $R_{HD\_G} = 100 \Omega$ ,  $R_{HD\_S} = 100 \Omega$ ). The zener clamping is necessary to protect the gate and source. The zener chains are used for avalanche clamping and protection against transients.

#### Table 10. High-side driver electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to +125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
HD_G		l l				<u> </u>
$V_{HD\_ON}$	HD_G switch-on voltage - with pd_on: PWMat 500 Hz, 50% duty cycle through the SPI • $5.5 \text{ V} \le \text{V}_{PWR} < 6.0 \text{ V}$ • $6.0 \text{ V} \le \text{V}_{PWR} < 7.0 \text{V}$ • $7.0 \text{ V} \le \text{V}_{PWR} < 10 \text{ V}$	V <sub>PWR</sub> +4 V <sub>PWR</sub> +5 V <sub>PWR</sub> +7	_ _ _	V <sub>PWR</sub> + 15 V <sub>PWR</sub> +15 V <sub>PWR</sub> +15	V	
	• 10 V ≤ V <sub>PWR</sub> < 36 V	V <sub>PWR</sub> +10	_	V <sub>PWR</sub> +15		
V <sub>HD_OFF</sub>	HD_G switch-off voltage	_	_	1	V	
t <sub>HD_ON</sub>	Turn-on time - After t <sub>HD_LC</sub>	_	_	1.4	ms	
I <sub>HD_OFF_SLOW</sub>	Turn-off current slow - V <sub>HD_G</sub> > 2.0 V. HPD_sr = 0	70	100	200	μΑ	
I <sub>HD_OFF_FAST</sub>	Turn-off current fast - V <sub>HD_G</sub> > 2.0 V, HPD_sr = 1	1.0	2.0	4.5	mA	
HD_S		'		· ·		ч
I <sub>LEAK_HD_SRC</sub>	Leakage current - $0 \le V_{HD\_S} \le 36 \text{ V}, 6.0 \le VPWR \le 36 \text{ V}$	_	_	50	μΑ	
HD_D		11				
L <sub>LEAK_HD_DRN</sub>	Leakage current - VCC5 = DOSV = 0 V, HD_D = PD_D = V <sub>PWR</sub> = 36 V	_	_	10	μА	
Overcurrent dete	ction					
V <sub>HD_OC</sub>	Overcurrent detection threshold - $V_{HD\_D}$ - $V_{HD\_S}$ , $R_{DRN}$ , $R_{SRC}$ = 100 $\Omega$	-15%	1.0	+15%	V	
Load leakage cur	rent detection					
I <sub>HD LC</sub>	HD_S source current	_	1.5	_	mA	

# 6.3 Pump motor pre-driver

# 6.3.1 Function description

This module is designed for pump motor predrivers, a maximum of 500 Hz PWM is possible. The pump motor pre-driver can be driven by a SPI command (pd\_on) or through the ADIN1 pin by selecting Adin1\_dis bit at "1".

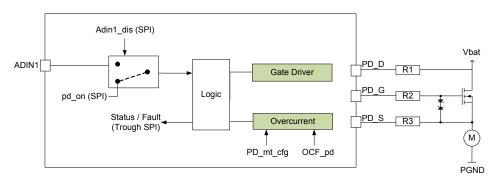


Figure 6. Pump motor predriver

### 6.3.2 Fault Detection

#### 6.3.2.1 Overcurrent

The pump pre-driver protects the external n-channel power FET on PD\_G in overcurrent conditions. The drain-source voltage of the FET on PD\_G is checked if the high-side predriver is switched on. If the measured drain-source voltage exceeds the overcurrent voltage threshold, the output of the overcurrent comparator is enabled. If the output of the comparator is active longer than the defined filter time, the output PD\_G is switched off. Overcurrent detection logic has a masking time from pd\_on turn-on against malfunctions in transient time. The masking time and filter time of the pump predriver is controllable by the SPI bit (See SPI and data register). After switching off the power FET on PD\_G by an overcurrent condition, the power FET can be turned back to a "normal state" by a SPI write 1 to the "PD\_cIr\_fit" register, and then turned on by a SPI command.

When the power FET is switched off, the gate capacitance of the FET is discharged by a constant current, which is controlled fast and slow by a SPI command (HPD sr).

# 6.3.2.2 External components of pump predriver

Protection of the resistors  $R_{PD\_D}$ ,  $R_{PD\_S}$ , and  $R_{PD\_S}$  is required (for example:  $R_{PD\_D} = 2.0 \text{ k}\Omega$ ,  $R_{PD\_G} = 100 \Omega$ ,  $R_{PD\_S} = 2.0 \text{ k}\Omega$ ). Zener clamping is necessary to protect the gate and source. The zener chains are used for avalanche clamping and protection against transients.

Table 11. Pump motor predriver electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to +125 °C, unless otherwise specified.

Parameter	Min.	Тур.	Max.	Unit	Notes
PD_G switch-on voltage - with pd_on: PWM at 500 Hz, 50% duty cycle through the SPI, 16 nF between PD_G & GND. pd_on = 1 without PWM $ \bullet 5.5\ V \le VPWR < 6.0\ V \\ \bullet 6.0\ V \le VPWR < 7.0V \\ \bullet 7.0\ V \le VPWR < 10\ V \\ \bullet 10\ V \le VPWR < 36\ V $	V <sub>PWR</sub> + 4 V <sub>PWR</sub> +5 V <sub>PWR</sub> +7 V <sub>PWR</sub> +10	- - - -	V <sub>PWR</sub> + 15 V <sub>PWR</sub> +15 V <sub>PWR</sub> +15 V <sub>PWR</sub> +15	٧	
PD_G switch-off voltage - pull-up current < 20 $\mu$ A	_	_	1	٧	
Turn-on time	-	0.5	_	ms	
Turn-off current slow - PD_G > 2.0 V. HPD_sr = 0	70	100	200	μΑ	
Turn-off current fast - PD_G >2.0 V, HPD_sr = 1	1.0	2.0	4.5	nA	
Leakage current - 0 ≤ VPD_src ≤ 36 V, 6.0 ≤ VPWR ≤ 36 V	-	_	10	μΑ	
Leakage current - VCC5 = DOSV = 0 V, HD_D = PD_D = VPWR = 36 V	_	_	10	μΑ	
ction					
Overcurrent detection threshold - $V_{PD\_D}$ - $V_{PD\_SRC}$ , $R_{DRN}$ , $R_{SRC}$ = 2.0 k $\Omega$	-15%	1.0	+15%	V	
Overcurrent detection filter time - OCF_pd = 0	_	T2	_	μs	
Overcurrent detection filter time - OCF_pd = 1	_	4*T1	_	μs	
	PD_G switch-on voltage - with pd_on: PWM at 500 Hz, 50% duty cycle through the SPI, 16 nF between PD_G & GND. pd_on = 1 without PWM $ \bullet 5.5 \text{ V} \leq \text{VPWR} < 6.0 \text{ V} \\ \bullet 6.0 \text{ V} \leq \text{VPWR} < 7.0 \text{ V} \\ \bullet 7.0 \text{ V} \leq \text{VPWR} < 36 \text{ V} \\ \hline \text{PD_G switch-off voltage - pull-up current} < 20 \mu\text{A} \\ \hline \text{Turn-on time} \\ \hline \text{Turn-off current slow - PD_G > 2.0 V. HPD_sr = 0} \\ \hline \text{Turn-off current fast - PD_G > 2.0 V, HPD_sr = 1} \\ \hline \text{Leakage current - 0} \leq \text{VPD_src} \leq 36 \text{ V}, 6.0 \leq \text{VPWR} \leq 36 \text{ V} \\ \hline \text{HD_D = PD_D = VPWR = 36 V} \\ \hline \text{Overcurrent detection threshold - V}_{\text{PD_D}} - \text{V}_{\text{PD_SRC}}, R_{\text{DRN}}, R_{\text{SRC}} = 2.0 \text{ k}\Omega \\ \hline \text{Overcurrent detection filter time - OCF_pd = 0} \\ \hline \end{tabular} $	$\begin{array}{c} PD\_G \ switch-on \ voltage - with \ pd\_on: \ PWM \ at 500 \ Hz, 50\% \ duty \ cycle \ through \ the SPI, 16 \ nF \ between \ PD\_G \ \& \ GND. \ pd\_on = 1 \ without \ PWM \\ \bullet \ 5.5 \ V \le VPWR < 6.0 \ V \\ \bullet \ 6.0 \ V \le VPWR < 7.0V \\ \bullet \ 7.0 \ V \le VPWR < 10 \ V \\ \bullet \ 10 \ V \le VPWR < 36 \ V \\ \end{array}$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

### 6.4 Low-side driver

# 6.4.1 Functional description

The SB0800 is designed to drive inductive loads in low-side configuration. All four channels are monitored by logic and faults are individually reported by the SPI. All external wiring to the loads and supply pins of the device are controlled. The device is self-protected against short-circuit and overtemperature at the outputs.

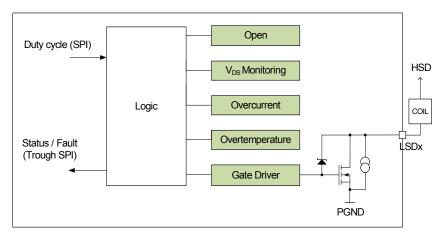


Figure 7. PWM low-side driver

Channel 1 to 4 can work either as current regulator or as PWM. When Channels 1 to 4 work as a current regulator, freewheeling diodes must be connected. Each channel comprises an output transistor, a predriver circuit, a diagnostic circuitry, and a current regulator. The SPI register defines the target output current. The output current is controlled through the output PWM of the power stage. The LSD1-4 current slopes are controlled by a SPI command to reduce switching loss.

The four power outputs consist of DMOS-power transistors with open drain outputs. The output transistor is equipped with an active clamp to limit the voltage at its output during turn-off with inductive loads. When the external fly-back diode is connected, the current re-circulation executes via the diode to the battery. When the diode is not connected, the PWM driver is equivalent to a digital driver. In those conditions, the inductive load forces the output voltage to increase until the voltage at the output is such that the output transistor turns on again. This lasts until the inductor current becomes zero. At that moment, the output transistor turns off. The predriver is in charge of applying the necessary voltage on the output transistor gate to minimize the On-resistance of the output switch.

The duty cycle of PWM low-side drivers is programmed via an 8-bit SPI message. The duty cycle between 0% and 100% can be selected and the LSB of the 8 bits is weighted with an 0.39% duty. Each channel has an 8-bit SPI register of PWM duty cycle.

The PWM low-side driver uses each channel as a digital low-side switch.

PWMx duty cycle = 1111 1111 - Digital low-side switch ON (conducting)

PWMx duty cycle = 0000 0000 - Digital low-side switch OFF

The SB0800 provides interleaved phase shift switching to minimize switching noise of the solenoid coil. Each LSD1 to 4 have this cycle.

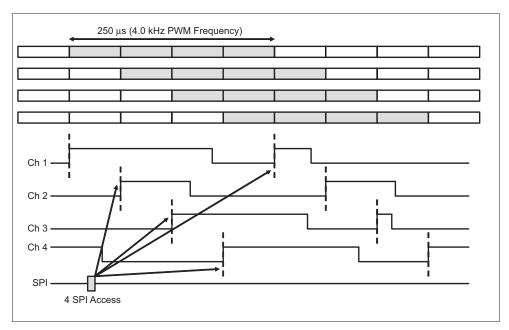


Figure 8. PWM valve control interleave

Table 12. Low-side driver electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to 125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Power output						
R <sub>ON_LSD14</sub>	On Resistance Channel 1 to 4: CR • $T_J$ = 125 °C; 9.0 V $\leq$ V <sub>PWR</sub> $\leq$ 36 V; I <sub>LOAD</sub> = 2.0 A	_	_	0.255	Ω	
R <sub>ON_LSD14_E</sub>	On Resistance Channel 1 to 4: CR (extended mode) • $T_J$ = 125 °C; 5.5 V $\leq$ V <sub>PWR</sub> $\leq$ 9.0 V; I <sub>LOAD</sub> = 2.0 A	_	_	0.33	Ω	
I <sub>LEAK_LSD</sub>	Drain Leakage Current • LSD = 36 V	_	_	10	μА	
V <sub>CL_LSD</sub>	Active Clamp Voltage	_	38	45	V	
Timings						
t <sub>R_CR1</sub>	Rise Time/Fall Time • 10% to 90%, I <sub>LOAD</sub> = 1.0 A, V <sub>PWR</sub> =24 V; no capacitor didt = 0 (SPI bit)	1.0 0.1	1.7 1.35	3.0 3.0	μs	
t <sub>R_CR2</sub>	Rise Time/Fall Time • 10% to 90%, I <sub>LOAD</sub> = 1.0 A, V <sub>PWR</sub> = 24 V; no capacitor didt = 1 (SPI bit)	0.05 0.1	0.5 1.0	1.0 3.0	μs	
t <sub>D</sub> on CR t <sub>D</sub> off CR	Turn on/off Delay Time • Digital 1 to 10% or 90%, I <sub>LOAD</sub> = 1.0 A, V <sub>PWR</sub> = 24 V, no capacitor	0.0	_	3.0	μs	(10)

Table 12. Low-side driver electrical characteristics (continued)

 $V_{PWR}$  = 6.0 to 36 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to 125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Timings		1	1	•		
LF_PWM	Output PWM frequency for LSD1-4  • LF_PWM xx = 111  • LF_PWM xx = 110  • LF_PWM xx = 101  • LF_PWM xx = 100  • LF_PWM xx = 000 (default)  • LF_PWM xx = 011  • LF_PWM xx = 001  • LF_PWM xx = 010	-20%	3.0 3.2 3.4 3.6 3.9 4.2 4.5 5.0	20%	kHz	
0000 0000 0000 0001  1111 1110 1111 1111	PWM Duty Cycle Programming (8-bits)  • Can be used for digital low-side driver	- - - -	OFF 0.39 — 99.61 ON	  -  -  -  -	%	

Notes

# 6.4.2 LSD1 to LSD4 current regulation driver

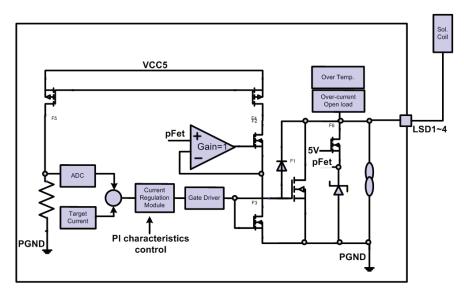


Figure 9. PWM low-side driver (current regulated)

The load current is sensed by an internal low-side sense FET and digitized by an internal A/D converter. The target value of the current is given SPI messages. A digital current regulation circuitry compares the actual load current with the target current value and steers the duty cycle of the low-side power switch. The PI regulator characteristic can be adjusted via the SPI.

<sup>10.</sup> Digital: internal digital signal delivered by interleave synchronization block. See Figure 8.

## 6.4.2.1 Target current

Each current regulator channel has its own 10-bit target current register. The LSB of the 10 bits is weighted with 2.2 mA. A zero value disables the power stage of the respective channel. A new target current is instantaneously passed to the settling time, which is the settling of the new current value.

PWMx target current value = 00 0000 0000 → 0 mA

PWMx target current value = 00 0000 0001 → 2.2 mA

...

PWMx target current value = 11 1111 1110 → 2.248 A

PWMx target current value = 11 1111 1111 → 2.250 A

CR_DIS12/34	CR_fb	Mode	LSD1-4 duty cycle (8-bit) or current read (10-bit)
0	0	current regulation	Read current target (to check SPI write)
0	1	current regulation	Read output duty cycle value for gate driver.
1	0	PWM	Read programmed PWM duty cycle (to check SPI write)
1	1	PWM	Read hardware ADC current value

### 6.4.2.2 Current measurement

The output current is measured during the "ON' phase of the low-side driver. A fraction of the output current is diverted and (using a "current mirror" circuit) generates across an internal resistance a voltage relative to ground, this being proportional to the output current.

### 6.4.3 PI characteristics

Digital PI-regulator with the Transfer function is programmed via the SPI register.

Transfer function: 
$$\frac{KI}{z-1} + KP$$

The integrator feedback register I charac bits define the regulation behavior of all channels. The default value is 1/8. Both current regulators remain idle until a non-zero value in I charac was programmed. A high proportional feedback value accelerates the regulator feedback and provides a faster settling of the regulated current after disturbances like battery voltage surge.

Table 13. Duty cycle descriptions

The duty cycle of PWM output is clamped minimum by options and maximum 100% (see 6.10, "SPI and data register").

Option	LLC<1>	LLC<0>	Minimum duty cycle
0	0	0	the measurement is done at t <sub>ON</sub> /2 by consequence     the regulation current will be set at t <sub>ON</sub> /2
1	0	1	<ul> <li>3.12%</li> <li>for a duty cycle &gt; 10%, the measurement is done at t<sub>ON</sub>/2</li> <li>for a duty cycle 3.2% &lt; DC &lt; 10%, the measurement is done at t<sub>ON</sub>/2 for 10% of duty cycle up at t<sub>ON</sub> for 3.2% of duty cycle</li> </ul>

#### Table 13. Duty cycle descriptions

The duty cycle of PWM output is clamped minimum by options and maximum 100% (see 6.10, "SPI and data register").

Option	LLC<1>	LLC<0>	Minimum duty cycle
2	1	0	3.12% + forced min duty cycle to 1.56% every two cycles  • for a duty cycle > 10%, the measurement is done at t <sub>ON</sub> /2  • for a duty cycle 3.2% < DC < 10%, the measurement is done at t <sub>ON</sub> /2 for 10% of duty cycle up at t <sub>ON</sub> for 3.2% of duty cycle  • for a duty cycle set at 1.56%, no measurement is done
3	1	1	<ul> <li>3.12% + skip min duty cycle every two cycles</li> <li>for a duty cycle &gt; 10%, the measurement is done at t<sub>ON</sub>/2 by consequence the regulation current will be set at t<sub>ON</sub>/2</li> <li>for a duty cycle 3.2% &lt; DC &lt; 10%, the measurement is done at t<sub>ON</sub>/2 for 10% of duty cycle up at t<sub>ON</sub> for 3.2% of duty cycle</li> <li>no measurement is done during the skipping mode</li> </ul>

If the target current value is not reached within the regulation error delay time of  $t_{CR\_ERR}$ , the flag of the SPI register "LSDx\_crer" is set to high. The current regulation loop is still running and tries to regulate at the target. Because it is not at the target, the duty cycle is either 100%, or minimum duty cycle by option. LSDx\_crer error detection has no effect on the driver, only SPI fault reporting. The microcontroller can detect the fault through the SPI (LSDx\_crer bit + ADC current reading), and shutdown the driver by sending 0 target current. Set Current – ADC result > "error threshold" during  $t_{CR\_ERR}$  then LSDx\_crer is set to 1.

This flag is latched & can be reset by the SPI read (LSDx\_crer). Each of the four current regulation low-side drivers can be used as a PWM low-side switch. CR\_disxx flag is enabled HIGH. The 8 MSB bits of the target current message are the PWM duty cycle. The first duty is controlled by the SPI bit FDCL (See SPI and data register).

Table 14. LSD1 to LSD4 current regulation driver electrical characteristics

V<sub>PWR</sub> = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V, T<sub>J</sub> = -40 to +125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Current regulation	on	1	II.	1	1	
0000 0000 0000 0001  1111 1111	Target current programming (10-bits)	_ _ _ _	OFF 2.2  2.25		mA A	
I <sub>CR_DEV</sub>	$\label{eq:maximum} \begin{array}{ll} \text{Maximum regulation deviation} \\ \bullet 0 \text{ mA} \leq I_{\text{TARGET}} < 50 \text{ mA, includes ADC error} \\ \bullet 50 \text{ mA} \leq I_{\text{TARGET}} < 100 \text{ mA, includes ADC error} \\ \bullet 100 \text{ mA} \leq I_{\text{TARGET}} < 250 \text{ mA, includes ADC error} \\ \bullet 250 \text{ mA} \leq I_{\text{TARGET}} < 400 \text{ mA, includes ADC error} \\ \bullet 400 \text{ mA} \leq I_{\text{TARGET}} < 2.25 \text{ A, includes ADC error} \end{array}$	_ _ _ _ _	_ _ _ _ _	65 50 25 ±10 ±2.0	mA %	(11)

#### Notes

11. Maximum regulation deviation performances noted in the table depend on external conditions (V<sub>PWR</sub>, load (R,L)).

SB0800

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# 6.5 Low-side driver for resistive load

# 6.5.1 Power output stages

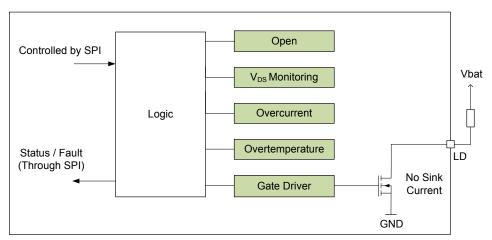


Figure 10. Low-side driver for resistive load diagram block

The low-side driver consists of DMOS-power transistors with open drain output. The low-side driver can be driven by SPI commands or by a MCU through the ADIN2. The low-side driver is composed of an output transistor, a predriver circuit, and diagnostic circuitry. The predriver applies the necessary voltage on the output transistor gate to minimize the On resistance of the output switch. To avoid leakage current path, LD has no sink current.

Table 15. Low-side driver electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to 125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Power output LD	•					•
R <sub>ON_LD</sub>	On Resistance for LD • $T_J$ = 125 °C, 6.0 V $\leq$ V <sub>PWR</sub> $\leq$ 36 V	_	_	14	Ω	
	DC Current Capability	_	_	20	mA	
I <sub>LEAK_LD</sub>	Drain Leakage Current • V <sub>PWR</sub> = 0, V <sub>CC5</sub> = 0, LD = 30 V, no sink current	_	_	5.0	μΑ	
Timings						
t <sub>D_ON_LD</sub>	Turn On Delay Time for LD	_	_	1.0	μs	(12)
t <sub>D_OFF_LD</sub>	Turn Off Delay Time for LD	_	_	1.0	μs	(12)

#### Notes

12. From Digital Signal to 50% (turn ON) or 50% (turn OFF).  $R_L$  = 1.0 k $\Omega$ ,  $V_{PWR}$  = 30V, no capacitor

### 6.5.2 Fault detection

#### Open load

An open condition is detected when the LD output is below the threshold  $OP_{LD}$  for the defined filter time  $t_{OP\_LD}$ , the fault bit is set Id\_OP (SPI error flag only). This function only operates during the off state.

#### V<sub>DS</sub> state monitoring

The  $V_{DS}$  state monitoring gives real time state of LD drain voltage vs  $OP_{LD}$  voltage. This signal is filtered and sent through the SPI vds\_ld bit. If the  $V_{DS}$  voltage is higher than  $OP_{LD}$  with a filter time (T1), vds\_ld is set to "1".

#### Overcurrent

When the current is above the overcurrent threshold  $OC_{LD}$  for the defined filter time  $t_{OC\_LD}$ , the driver is switched off, a SPI fault bit Id\_OC is set, and the turn-on SPI command is cleared. The driver can be returned to the "normal state" by a SPI write "1" to "LD\_clr\_flt", then turned on by a SPI command (LD\_on).

#### Overtemperature

When the temperature is above the overtemperature threshold  $OT_{LD}$  for the defined filter time  $t_{OT\_LD}$ , the driver is switched off, a SPI fault bit  $Id\_OT$  is set, and the turn-on SPI command is cleared. The driver can be returned to the "normal state" when the temperature returns to the normal state, a SPI write "1" to "LD\_clr\_flt", then turning on a SPI command (LD\_on).

#### Table 16. Low-side driver electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to 125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes	
Overcurrent shut	Overcurrent shutdown						
OC <sub>LD</sub>	Overcurrent Shutdown Threshold Current for LD	_	100	_	mA		
t <sub>OC_LD</sub>	Overcurrent Shutdown Filter Time	_	T1	_	μs		
Open load detect	ion						
OP <sub>LD</sub>	Open Load Detection Threshold (also used for V <sub>DS</sub> monitoring)	_	2.0	_	V		
t <sub>OP_LD</sub>	Open Load Detection Filter Time	_	T2	_	μs		
V <sub>DS</sub> monitoring							
t <sub>VDS_LD</sub>	V <sub>DS</sub> State Filter Time (rise & fall edge filter time)	_	T1	_	μs		
Overtemperature	shutdown						
OT <sub>LD</sub>	Overtemperature Detection Threshold	180	195	210	°C		
t <sub>OT_LD</sub>	Overtemperature Detection Filter Time	_	T1	_	μs		

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# 6.6 Analog to digital converter (x3ch)

ADC is referenced to VCC5 voltage and converts the voltage on 10 bits. It is used to read the following voltages:

- · Three analog input pins: ADINx
- Internal voltage supplies (VINT\_A, VINT\_D,  $V_{PRE10}$ ,  $V_{PRE12}$ ,  $V_{CP\_VPWR}$ )
- Average temperature of die, which is used by the temperature warning detection circuit (TEMP). Refer to the SPI Message Structure, Message #9.
- · Allows to read the current drain by the LSD1-4 in PWM mode.

Also, it is possible to use ADIN1 and / or ADIN2 to control respectively the motor pump and / or the low-side driver for resistive load directly by the MCU.

Table 17. Direct control of pump and low-side

Adin1_dis	Pump control
0	Pd_on bit (SPI command)
1	By MCU
Adin2_en	Low-side for resistive load control
0	By MCU
1	Ld_on (SPI command)

#### Table 18. ADC electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to 125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
ADC	-			l .		
A <sub>DC_ERR</sub>	Total Error - 0 < ADINx < VCC5	_	3	_	LSB	(13)
t <sub>CONV</sub>	Conversion Time	_	6.6	_	μs	
t <sub>RFT</sub>	Refresh Time - min ADC update time; shorter than 1.0 ms	_	100	_	μs	
DINx	•	•		•		•
I <sub>ADI_LK</sub>	Input Leakage Current - 0 < ADINx < VCC5	-10.0	_	10.0	μΑ	
C <sub>ADI_CAP</sub>	DI_CAP Input Capacitance		_	30	pF	
nternal voltage						
A <sub>D_VINT_A</sub>	Voltage of internal analog regulator	440	512	590	LSB	
A <sub>D_VINT_D</sub>	Voltage of internal digital regulator	440	512	590	LSB	
A <sub>D_VPRE10</sub>	V <sub>PRE10</sub> - ADC ratio =V <sub>PRE10</sub> /3.3, 9.0 < V <sub>PWR</sub> < 36 V	400	600	800	LSB	
A <sub>D_VPRE12</sub>	V <sub>PRE12</sub> - ADC ratio = V <sub>PRE12</sub> /3.0, 9.0 < V <sub>PWR</sub> < 36 V	590	790	980	LSB	
A <sub>D_VCP</sub>	$V_{CP-}V_{PRWR}$ - ADC ratio = $V_{CP}$ - $V_{PWR}/4.0$ , $9.0 < V_{PWR} < 36 V$	330	_	810	LSB	
emperature rea	ding					
A <sub>D_TEMP25</sub>	Voltage at 25 °C	_	717	_	LSB	
A <sub>D_DEV_TEMP</sub>	deviation with 1.0 °C increments	_	-2.0		LSB/°C	

#### Notes

<sup>13.</sup> If ADINx voltage is between VCC5 to max\_rating, the ADC value does not change. Also between VCC5 min and GND, the ADC value does not change.

<sup>14.</sup> SW engineer can monitor internal supply voltage in real time with ADC, SPI reading, and can use fail-safe function.

# 6.7 High-side

# 6.7.1 Function description

The device has one high-side, having an integrated high-side switch, controlled by the SPI command HS\_on. It allows connecting and disconnecting loads like voltage dividers from the supply line, to reach low quiescent current of the total ECU or to driver small size relay driver.

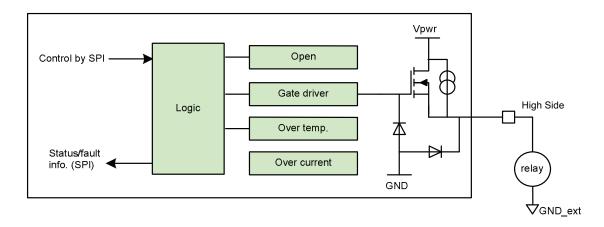


Figure 11. High-side driver

#### 6.7.2 Fault detection

#### 6.7.2.1 Ground shift

With a 2.0 V GND shift on the external relay coil (50  $\Omega$ ), 30 mA could flow through the high-side output (diode between the SB0800\_gnd & the high-side output) without damage to the SB0800 (see <u>Figure 11</u>).

# 6.7.2.2 **Open load**

An open condition is detected when the high-side output is higher than the threshold OP\_HS for the defined filter time  $t_{OP\_HS}$ . The fault bit is set HS\_op (SPI error flag only). The function only operates during the off state.

# 6.7.2.3 V<sub>DS</sub> state monitoring

The  $V_{DS}$  state monitoring gives the real time state of HS drain voltage vs. OP\_HS voltage. This signal is filtered and sent through the SPI vds\_HS bit. If the HS output is lower than OP\_hs with a filter time (T1), vds\_HS is set to "1".

#### 6.7.2.4 Overcurrent

When the current is above the overcurrent threshold OC\_hs for the defined filter time t<sub>OC\_HS</sub>, the driver is switched off, a SPI fault bit HS\_oc is set, and the turn-on SPI command is cleared. The driver can be turned back to a "normal state" by a SPI write "1" to "HS\_clr\_flt", then a turn on by the SPI command (HS\_on).

### 6.7.2.5 Overtemperature

When the temperature is above the overtemperature threshold OT\_hs for the defined filter time t<sub>OT\_HS</sub>, the driver is switched off, a SPI fault bit HS\_ot is set, and the turn-on SPI command is cleared. The driver can be turned back to a "normal state" when the temperature returns to a normal state, a SPI write "1" to "HS clr flt", and then a turn on by the SPI command (HS on).

#### Table 19. High-side electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to +125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Power output HS			II.	II.	1	
R <sub>ON_HS</sub>	On resistance • $T_J$ = 125 °C, 9.0 V ≤ $V_{PWR}$ ≤ 36 V • $T_J$ = 125 °C, 6.0 V ≤ $V_{PWR}$ ≤ 9.0 V	_ _		1.0 1.5	Ω	
	DC current capability	_	270	_	mA	
I <sub>LEAK_HS</sub>	Drain leakage current - V <sub>PWR</sub> = 14 V, V <sub>CC5</sub> = 0	_	_	2.0	μΑ	
V_BVDSS_HS	Breakdown Voltage	40	_	_	V	
Timing			•	•		
t <sub>D_ON_HS</sub> / t <sub>D_OFF_HS</sub>	Turn on/off delay time	_	_	20	μs	(15)
Overcurrent shut	down		•	•		
OC_ <sub>HS</sub>	Overcurrent shutdown threshold current	_	650	_	mA	
t <sub>oc_Hs</sub>	Overcurrent shutdown filter time - measured by sense FET	_	T1	_	μs	
Open load detect	ion					
OP_HS	Open load detection threshold - include GND shift = 2.0 V, also used for $V_{DS}$ monitoring	_	4.0	_	V	
V <sub>DS</sub> monitoring						
t <sub>VDS_HS</sub>	V <sub>DS</sub> state filter time	_	T1	_	μs	(16)
Overtemperature	shutdown					•
OT_HS	Overtemperature detection threshold	180	195	210	°C	
t <sub>OT_HS</sub>	Overtemperature detection filter time	_	T1	_	μs	

#### Notes

<sup>15.</sup> From digital signal to 50% (turn ON) or 50% (turn OFF).  $R_L$ =1.0 K $\Omega$ ,  $V_{PWR}$  = 30 V, no capacitor

<sup>16.</sup> Used open load detection comparator rise & fall edge filter time

# 6.8 Monitoring module

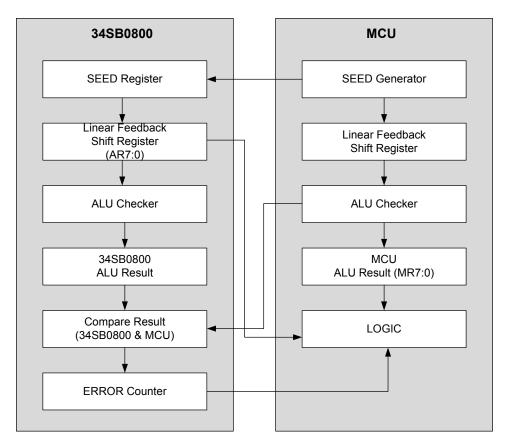


Figure 12. Block diagram of SB0800 monitoring module and MCU

The monitoring module in SB0800 works independently from the MCU functionality. The SEED is an 8-bit word, initializing the monitoring module and transferred by the SPI. The MCU generates the SEED, and must fetch and send correct calculation results (MR7:0) to the SB0800 monitoring module within a defined time window. The SB0800 monitoring module confirms the result is sent and correct in the time window. ALU checker results of SB0800 monitoring module are transferred to the MCU by the SPI. The monitoring module also calculates the expected correct result, which is compared to the actual result from MCU.

The result from MCU is an 8-bit MR. The 8 bits are sent to the monitoring module via the SPI interface. The monitoring cycle time starts by a write of MR, with the next MR written within in a fixed time window. A new cycle time is started automatically by a write of MR.

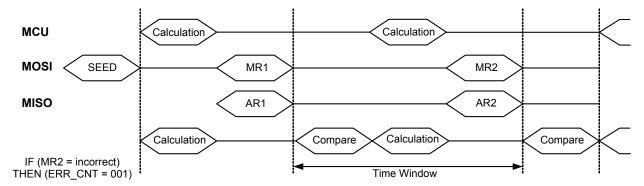


Figure 13. Timing diagram of SB0800 monitoring module and MCU

ERR\_CNT is a 3-bit counter. An incorrect result leads to incrementing the ERR\_CNT by one, and a correct result leads to decrementing by one. The ERR\_CNT 3-bit can be read by the SPI interface.

# 6.8.1 ERR\_CNT behavior

Reset with (RSTB pin = "Low")

```
IF (ERR CNT ≥ 101) THEN (RSTB pin = "Low") AND (MON_CNT reset)
```

IF (ERR CNT ≤ 100) AND (MR = incorrect) THEN (ERR CNT = ERR CNT+1)

IF (ERR\_CNT = 000) AND (MR = correct) THEN (ERR\_CNT = ERR\_CNT)

IF (001 ≤ MON\_CNT ≤ 100) AND (MR = correct) THEN (ERR\_CNT = ERR\_CNT - 1)

The SB0800 monitors the time window of the SPI message #18 without writing to the SEED. The time window ( $t_{WD}$ ) counter starts with the RSTB pin rising edge. The time window ( $t_{WD}$ ) counter is reset with the SPI message #18 (with valid parity bit) and restart. If the SPI message #18 (with valid parity bit) is not transferred from the MCU before the time window ( $t_{WD}$ ) end period, the RSTB pin goes to a LOW state for the duration time of  $t_{RSTB\_REC}$  and the RST\_wd flag is set "High". When RSTB is at a low state (internal, external), the time window ( $t_{WD}$ ) counter is reset to zero.

# 6.8.2 Linear feedback shift register (LFSR)

Both the SB0800 monitoring module and the MCU have LFSR for a pseudo-random number generator of ALU checker inputs. LFSR works in parallel with the SB0800 and MCU. LFSR is initialized by the SPI with a SEED 8-bit, then each MR write command generates a new pseudo-random number. The FF hex-value cannot be used for the SEED.

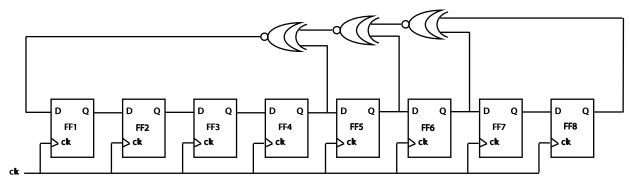


Figure 14. Diagram of linear feedback shift register (LFSR)

### 6.8.3 ALU checker

Both the SB0800 monitoring module and the MCU have an ALU checker. The ALU checker work in parallel with the SB0800 and MCU. The 8-bit input of the ALU checker is the 8-bit output of LFSR. The ALU checker proceeds on five sequential calculations.

Multiplier pseudo-random value by fix value 4 Adder output multiplier by fix value 6 Subtract previous value with fix value 4 Inverting previous value: bitwise complement Divider previous value by fix value 4

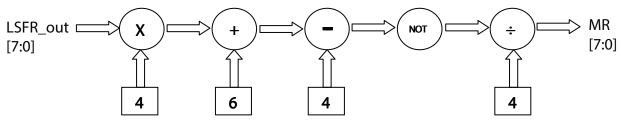


Figure 15. Diagram of ALU checker

#### Table 20. Monitoring module electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to +125 °C, unless otherwise specified.

Symbol	Parameter	Min.	Тур.	Max.	Unit	Notes
MCU monitoring n	nodule					
t <sub>WD</sub>	Timing window for Watchdog	10	_	60	ms	
t <sub>VAM</sub>	t <sub>VAM</sub> Variation of the Watchdog Window Timing		75	90	ms	

#### Notes

17. The maximum setting window for the watchdog can be decreased to a SPI timing access. The range given in Table 33 shows the typical use case.

Sequence examples to run the watchdog:

Check when the pin reset goes high.

1st command: send the message 0: 0x00 to clear flags

2nd command: send the message 0: 0x00 to reinitialize the seed value. Then, no need to send the seed value again

3rd command: message 18: send the corresponding MR value calculated due the the seed value

4th: send the message desired

Note: The message 18 (MR value) should be sent according the the tWD timing

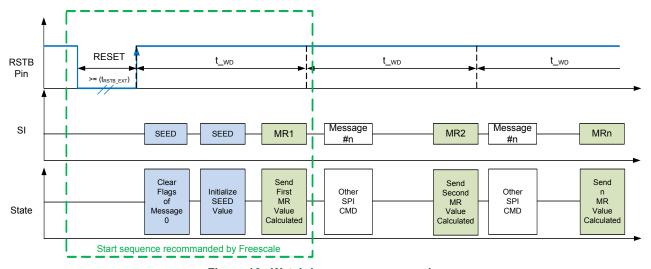


Figure 16. Watchdog sequence example

# 6.9 Supervision

Table 21. Reaction to supply fault and reset condition

Event	RSTB	LSDx	HD	PD	LD	SPI	Notes
Normal mode: After RSTB rising edge, No fault	High	Normal	Normal	Normal	Normal	Normal	
VINT_x undervoltage	Low (output)	OFF	OFF	OFF	OFF	SPI register go to initial state Low except for Vint_uv which is reset to 1. After first read of Vint_uv, it is set back to 0.	(18)
Clock fail reset	Low (output)	OFF	OFF	OFF	OFF	SPI registers go to initial state Low except for Vint_uv unchanged & RST_clk which is set to 1. After first read of RST_clk, it is set back to 0.	(18)

Table 21. Reaction to supply fault and reset condition (continued)

Event	RSTB	LSDx	HD	PD	LD	SPI	Notes
DOSV undervoltage	Low (output)	OFF	OFF after t <sub>LSDx_HD_G</sub>	OFF	OFF	SPI register go to initial state except reset flag (Vint_uv, VCC5_uv, DOSV_uv, RST_wd, RST_alu, RST_ext, RST_CLK) and hd_on (tLSDx_HD_G timing).	(18)
VCC5 undervoltage	Low (output)	OFF	OFF after t <sub>LSDx_HD_G</sub>	OFF	OFF	SPI register go to initial state except reset flag (Vint_uv, VCC5_uv, DOSV_uv, RST_wd, RST_alu, RST_ext, RST_CLK) and hd_on (tLSDx_HD_G timing).	(18)
Watchdog fault or ALU fault	Low during tRSTB_REC (output)	OFF	OFF after t <sub>LSDx_HD_G</sub>	OFF	OFF	SPI register go to initial state except: - reset flag (Vint_uv, VCC5_uv, DOSV_uv, RST_wd, RST_alu, RST_ext, RST_CLK) - clear flag bits - hd_on (tLSDx_HD_G timing) MR - Seed  Note: P_charac and I_charac bits are reset in case of Watchdog fault or ALU fault, but SPI read returns the direct SPI write content.	(18)
External Reset	Low (input)	OFF	OFF after t <sub>LSDx_HD_G</sub>	OFF	OFF	Same SPI behavior as Watchdog fault or ALU fault except seed.  SPI register go to initial state except: - reset flag (Vint_uv, VCC5_uv, DOSV_uv, RST_wd, RST_alu, RST_ext, RST_CLK) - clear flag bits - hd_on (tLSDx_HD_G timing) MR  Notes: P_charac and I_charac bits are reset in case of external reset, but SPI read returns the direct SPI write content.  Watchdog circuit Seed register (written by SPI write Message #0) is reset by External reset event and impossible to write to unless External reset flag is cleared. In the case of External reset, two identical SPI write Message #0 should be executed to reinitialize Seed register. First SPI Message #0 will clear External reset flag and second SPI Message #0 will finally reinitialize Seed register. In application, writing seed is preferred after checking if RST_ext is 1. (Only External Reset flag is to block writing Seed.)	
VPWR overvoltage	No effect	OFF	OFF after t <sub>LSDx_HD_G</sub>	On	No effect	Following SPI registers go to initial state Low: A. LSDx Duty cycle or current set point. B. hd_on	
VPWR undervoltage	No effect	OFF	OFF after t <sub>LSDx_HD_G</sub>	OFF	No effect	Following SPI registers go to initial state Low: A. LSDx Duty cycle or current set point. B. hd_on	

#### Notes

#### Restart conditions:

SPI write message #0 has first to be executed to clear any reset or fault flags. Then new SPI command can be sent.

Table 22. Start point of reset recovery time

Fault mode	Start point of t <sub>RST_REC</sub>
VINT_A or VINT_D_uv or VCC_uv or DOSV_uv	Come back normal voltage of all voltages
Watchdog or ALU fault	Fall edge of RSTB pin

<sup>18.</sup> State defines for the duration of the fault and the following reset recovery time period.

# 6.9.1 Additional safety functions

# 6.9.1.1 VINT\_A or VINT\_D undervoltage supervision

The SB0800 uses an internal supply for analog functions (VINT\_A) and digital functions (VINT\_D). The supply voltage VINT\_A and VINT\_D are supervised for undervoltage. When the voltage becomes lower than each threshold VINT\_A\_uv and VINT\_D\_uv, the RSTB pin is asserted low after detection filter time ( $t_{VINT}$ ). This reset state will continue until the voltage at pin VINT raises again. And if VINT becomes higher than each threshold VINT\_A\_uv and VINT\_D\_uv for same filter time ( $t_{VINT}$ ), the RSTB Pin goes high after reset recovery time ( $t_{RST\_REC}$ ) and the related flag of the SPI register is set to high. For stabilization the internal supply VINT\_A & VINT\_D requires external capacitors. Two band-gaps are included in the SB0800, one is for the voltage reference and the other is for the diagnostic. The VINT\_A and VINT\_D voltages are sending through the SPI.

### 6.9.1.2 VCC5 supervision

See Table 21 Reset condition and reaction.

### 6.9.1.3 DOSV supervision

The supply voltage DOSV is supervised for undervoltage. When the voltage at pin DOSV becomes lower than DOSV\_uv, the RST pin is asserted low after detection filter time ( $t_{VDUV}$ ). This reset state will continue until the voltage at pin DOSV raises again. And if DOSV becomes higher than (DOSV\_uv) for same filter time ( $t_{VDUV}$ ), the RSTB Pin goes high after reset recovery time ( $t_{RST\_REC}$ ) and the related flag of the SPI register is set to high.

The P53\_CFG pin decides the DOSV pin undervoltage threshold.

Pin	Condition	Description
P53 CFG	Short to GND	5.0 V DOSV undervoltage threshold
1 33_01 0	Short to VCC5	3.3V DOSV undervoltage threshold

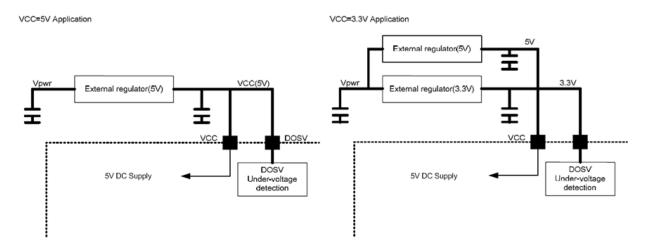


Figure 17. Configuration of VCC5 and DOSV for 5.0 V or 3.3 V application

# 6.9.1.4 Charge pump

The charge pump generates a voltage of typically 12 V above the supply  $V_{PWR}$ . The charge pump voltage is intended for internal use only. No additional load shall be connected to the CP pin. The charge pump requires a capacitor for energy storage and to cover transients. The voltage difference between CP and VPWR can be read by the SPI.

# 6.9.1.5 Internal clock supervision (mismatch MAIN-AUX CLK)

The SB0800 has two independent clock modules, one is the main supply clock to all SB0800 systems. The other monitors the main clock fault and if a fault is detected, the SB0800 resets with the RST\_CLK function (<u>Table 21</u>). This function starts when RSTB is in a high state.

Mutual Supervision of Both Main and Auxiliary Clock:

Clock monitoring continues to perform comparisons between the two clocks sources, CLK1 and CLK2. When everything is working correctly, both clocks are present and both have the same frequency of 14 MHz. If one of the clocks stops or if clocks are misaligned in frequency more than  $\pm 25\%$  of 14 MHz (Table 23), an RSTB reset is generated (Table 21) and a SPI flag is reported (RST\_CLK). The reset flag RST\_CLK (same as other reset flags) is cleared in "clear on read" fashion, or in other words, the flag is cleared by a SPI Read command that reads the flag. In the case of a clock monitoring fault, the clock monitoring process will restart only after the clock monitoring flag (RST\_CLK) is cleared on the first SPI message.

If either CLK1or CLK2 disappears indefinitely, the clock monitoring fault will show anywhere from T1 to 2\*T2. If clock frequencies are misaligned in more than ±25% of 14 MHz, the clock monitoring fault will show after a time delay of T2, as measured by the reference clock CLK1. The misaligned frequency detection error is measured in time window of T2 and the measurement is based on CLK1 clock as reference, therefore if the CLK1 frequency changes, the time window T2 cannot be guaranteed.

The SB0800 internal clock monitoring function can be disabled by the SPI command (StopCLK2), with no effect of functionality except the clock monitoring function, because CLK1 is activated, but CLK2 is deactivated. Frequency modulation can be controlled by the FM\_amp and FM\_EM bits (See SPI and data register). The SPI command (FM\_EN) enables the frequency modulated oscillator by two deviation frequency to spread the oscillator's energy over a wide frequency band. There are two kinds of deviation frequencies (350 kHz and 700 kHz), which are decided by the SPI command (FM\_amp). This spreading decreases the peak electromagnetic radiation level and improves electromagnetic compatibility (EMC) performance.

If preferred, the sequence following by SPI command (StopCLK2), and later on if decided to reactivate the CLK2 (clock monitoring reactivated), a reset clk can be generated due to the fact the clk2 re-start, and can have a settling time > 2\*T2, 1.0 ms max. In this case, reset is detected during reset recovery time and the CLK RST (reading message #0) flag should read in a normal condition.

### 6.9.1.6 Die temperature warning

The SB0800 has 1 temperature warning sensor in the cool place of the die. The threshold of temperature warning is 20 °C below overtemperature. In case of a temperature warning, outputs are not shutdown and the SPI-Bit shows the actual status at accessing time.

# 6.9.1.7 Ground supervision

GND-loss monitors the voltage between PGND (global reference GND) and GND\_D. In case of a disconnection of GND\_D vs. all other grounds (pin 2, 4, 13, 37, 46, 51, and back side ground are soldered to ground), a detection GND\_D disconnect as soon as the GND\_D is higher than the threshold (V\_GL) vs. others grounds, is reported through the flag FGND via the SPI register and set high after a filter time (t<sub>GL</sub>).

- 1. Connection degraded (resistive path)
  - A. GND\_D vs other grounds > V\_GL but by having Vint\_D -GND\_D > min voltage required
  - B. SPI communication still possible, and the flag FGND will be at 1
- Disconnection (open physically) during a sequence (in Normal mode), the logic embedded will be frozen, because the voltage Vint\_D -GND\_D < min voltage required</li>
  - A. No SPI communication is possible
  - B. If GND D is reconnected normally, SPI communication recovers and the flag FGND will be at 1

#### Table 23. Electrical characteristics

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to +125 °C, unless otherwise specified.

	•					
Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Reset output SB0	800 to MCU		I.	l	II.	·I
t <sub>RSTB_REC</sub>	Reset Recovery Time	-20%	45	20%	ms	
Reset input MCU	to SB0800			I	I.	I
t <sub>RST_MIN</sub>	Minimum External Reset Time (only for application)	_	10	_	μs	
DOSV undervolta	ge				l .	
DOSV <sub>UV_5V</sub> DOSV <sub>UV_3P3</sub>	Undervoltage Reset Threshold at Shutdown (falling edge of DOSV)  • P53_CFG = Low (< 0.8 V)  • P53_CFG = High (> 2.0 V)		4.5 2.9	_	V	
t <sub>DVUV</sub>	Undervoltage Reset Filter Time	_	T1	_	μs	
VCC5 undervolta	ge				l .	
VCC5_UV	Undervoltage Threshold	_	4.5	_	V	
t <sub>VCUV</sub>	Undervoltage Filter Time	_	T1	_	μs	
VCC5 supply		.1		l	I.	I
I_vcc5	Consumption Current  • VCC5 = 5.0 V; HD,PD = on; RSTB = high  • During SPI communication			20 10	mA	

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### Table 23. Electrical characteristics (continued)

 $V_{PWR}$  = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_{J}$  = -40 to +125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Internal logic sup	ply				•	•
Vint_A	Internal Analog Voltage - I <sub>LOAD</sub> = -10 mA	2.30	2.5	2.8	V	
Vint_D	Internal Digital Voltage - I <sub>LOAD</sub> = -10 mA	2.30	2.5	2.8	V	
C_Vint	Stabilization Capacitor at V_INT - Low-voltage capacitor (<4.0 V)	_	220	_	nF	
nternal logic sup	ply undervoltage	•	•			ul
Vint_A_ <sub>UV</sub> Vint_D_ <sub>UV</sub>	Undervoltage Reset threshold	_	2.0	_	V	
t <sub>VINT</sub>	Undervoltage Reset Filter time	_	1.0	_	μs	
/PWR supply	1				l.	1
I_ <sub>VPWR</sub>	Consumption current - VPWR = 36 V, HD, PD = on, RSTB = high	_	5.0	_	mA	
I_STBY_VPWR	Consumption current at sleep mode - VCC5 = DOSV = 0 V, HD_D = PD_D = VPWR = 36 V	_	2.0	20	μА	
/PWR overvoltag	e e					
VPWR_OV	VPWR Overvoltage Threshold (rising edge)	_	38	_	V	
VPWR_OV_HYS	Overvoltage Detection Hysteresis - VPWR_OV(ON) = VPWR_OV(SHUTDOWN) - VPWR_OV_HYS	_	0.6	1.0	V	
t <sub>VPWR_OV</sub>	t <sub>VPWR_OV</sub> Overvoltage Detection Filter Time - Both directions		T2	_	μs	
/PWR undervolta	ge	1			Į.	+
VPWR_UV	Undervoltage Shutdown Threshold (falling edge)	_	5.1	_	V	
VPWR_UV_HYS	Undervoltage Detection Hysteresis - VPWR_OV(ON) = VPWR_OV(SHUTDOWN) -VPWR_OV_HYS	30	100	200	mV	
t <sub>VPUV</sub>	Undervoltage Detection Filter Time	_	T2	_	μs	
Ground-loss dete	ction					1
V_GL	GND_d-loss detection threshold - Reference GND_Px	_	0.5	_	V	
t <sub>GL</sub>	GND_d-loss detection filter time - Reference GND_Px	_	T2	_	μs	
Oscillator	<u> </u>					1
f_osc	Main Oscillator Frequency	-7.0%	14	7.0%	MHz	
e <sub>CLK</sub>	Mismatch MAIN-AUX OSC CLK - enable V <sub>INT_X</sub> is normal voltage digital comparison between the two clocks.	_	±25	_	%	
t <sub>CLK</sub>	Mismatch OSC Filter Time	T1	T2	2*T2	μs	(19)
	Frequency Modulation Band 1 - FM_amp = 0	_	350	_	kHz	
	Frequency Modulation Band 2 - FM_amp = 1	_	700	_	kHz	
	Frequency Modulation Speed	_	110	_	kHz	†
Overtemperature/	l /temperature warning		1		<u> </u>	1
T <sub>W</sub>	Temperature Warning Detection Threshold	150	165	180	°C	
t <sub>TW</sub>	Temperature Warning Detection Filter Time	_	T2	_	μs	1
Charge pump	1	1	1		<u>.</u>	
C <sub>CP</sub>	Charge pump external capacitor - Tolerance < ±20%	_	220		nF	
V_CP	Charge pump voltage - hd_on = pd_on = 1, LSD 100% duty cycle.		V <sub>PWR</sub> +13		V	(20)

#### SB0800

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#### Table 23. Electrical characteristics (continued)

V<sub>PWR</sub> = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V, T<sub>J</sub> = -40 to +125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
Timing						
T1	Logic time base T1	14.4	18.2	22	μs	
T2	Logic time base T2	232	293	360	μs	

#### Notes

- 19. The t<sub>CLK</sub> parameter is decided by a frequency checker and comparing two clocks. If either main clock or AUX clock frequency disappears longer than T1, the SB0800 goes to reset by the clock frequency checker and the CLK\_RST flag will be detected. Meanwhile, comparing the main clock and AUX clock is done during T2 and the SB0800 is possible to go to reset every T2. Because measurement and reset activation are asynchronous, t<sub>CLK</sub> can reach 2\*T2 in the worst case by comparing two clocks.
- 20. For more details, refer to the HD\_G & PD\_G parameters

Write 1 to any xxx\_clr\_flt register will create a reset of the fault flag during 1 clock period after the SPI message. xxx\_clr\_flt automatically goes to "0" after 1 clock from fault flag reset.

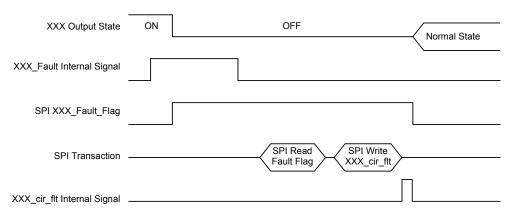


Figure 18. Timing diagram of xxx\_clr\_flt

### 6.10 SPI and data register

### 6.10.1 Function description

The SPI serial interface has the following features:

- · Full duplex, four-wire synchronous communication
- Slave mode operation only
- · Fixed SCLK polarity and phase requirements
- · Fixed 16-bit command word
- SCLK operation up to 10.0 MHz

The Serial Peripheral Interface (SPI) is used to transmit and receive data synchronously with the MCU. Communication occurs over a full-duplex, four-wire SPI bus. The 34SB0800 device operates only as a slave device to the master, and requires four external pins; SI, SO, SCLK, and CSB. All words are 16 bits long and MSB is sent first.

The SPI simultaneously turns on the serial output SO and returns the MISO return bits. When receiving, valid data is latched on the rising edge of each SCLK pulse. The serial output data is available on the rising edge of SCLK, and transitions on the falling edge of SCLK. The number of clock cycles occurring on the pin SCLK while the CSB pin is asserted low must be 16. If the number of clock pulses is not 16 or a parity fault, the SPI MOSI data is ignored. The SB0800 takes even parity. On next data read SO message, "Fmsg" bit sets to 1, and other data bits sets to 0. The parity bit sets to 1. On the first SPI communication after reset, the read SO message sets to 10101010101010.

The fault registers are double buffered. The first buffer layer latches a fault at the time the fault is detected. This inner layer buffer clears when the fault condition is no longer present and the fault bit communicates to the MCU by a MISO response. The second layer buffer latches the output of the inner layer buffer whenever the CSB pin transitions from low to high. The output of the second layer buffer is transferred to the shift register after the corresponding MOSI command is received from the MCU.

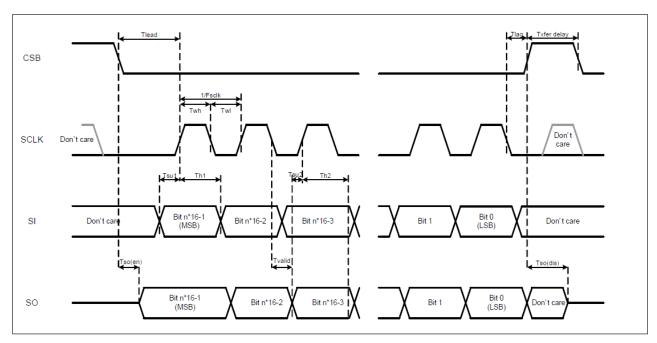


Figure 19. SPI timing diagram

Table 24. SPI timing electrical characteristics

VPWR = 6.0 to 36 V, VCC5 = 4.75 to 5.25 V, DOSV = 3.13 to 5.25 V,  $T_J$  = -40 to 125 °C, unless otherwise specified.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
SPI interface timi	ing <sup>(21)</sup>			l .	l .	
f <sub>SPI</sub>	Recommended Frequency of SPI Operation - t <sub>SPI</sub> = 1/f <sub>SPI</sub>	_	_	10	MHz	
t <sub>LEAD</sub>	Falling Edge of CSB to the Rising Edge of SCLK (required setup time)	_	t <sub>SPI</sub> /2	50	ns	
t <sub>LAG</sub>	Falling Edge of SCLK to the Rising Edge of CSB (required setup time)	_	t <sub>SPI</sub> /2	50	ns	
T <sub>XFER_DELAY</sub>	No Data Time Between SPI Commands	_	_	_	ns	
t <sub>WH</sub>	High Time of SCLK	_	t <sub>SPI</sub> /2	_	ns	
t <sub>WL</sub>	Low Time of SCLK	_	t <sub>SPI</sub> /2	_	ns	
t <sub>SU1</sub>	SI to Rising Edge of SCLK (required setup time)	_	_	_	ns	
t <sub>SO(EN)</sub>	Time from Falling Edge of CSB to SO Low-impedance	_	_	30	ns	
t <sub>SO(DIS)</sub>	Time from Rising Edge of CSB to SO High-impedance	_	_	30	ns	
t <sub>VALID</sub>	Time from Falling Edge of SCLK to SO Data_valid - 0.2xDOSV ≤ 0.8xDOSV, CL = 50 pF	_	_	30	ns	

#### Notes

21. The inputs of the SPI module (SCLK, CSB, SI) are driven between 0 V and DOSV voltage.

## 6.10.2 SPI message structure

addr #						W	rite											Re	ead						
DEC	BIN	9	8	7	6	5	4	3	2	1	0	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	00000				SED	<7:0>	ı			HPD_s	PD_mt _cfg		Ver	Version         dosv_u         Vcc_ v         Vint_ uv         RST_ cl k         RST_ ext         RST_ alu         RST_ wd         X         HP						HPD_s	PD_mt _cfg				
1	00001		P ch	narac			I charac		lsd_sin k_dis	1	0		Manufact	uring data	3		P cl	harac			I charac		lsd_sin k_dis	х	х
2	00010												Res	erved											
3	00011	0	0	0	0	FM_ amp	FM_ EN	StopC L K2	Adin2_ en	Adin1_ dis	OCF_p			SB	0800_CL	K_CNT<	7:0>			Vpwr_ ov	х	Vpwr_ uv	FGND	OTW	х
4	00100	0	0	0	0	0	0	0	0	0	0	0	Х	Х	Х					TEMP	<9:0>				
5	00101	0	0	0	0	pd_on	hd_on	0	0	HS_on	LD_on	PD_oc	HD_oc	Х	Х					VINT_I	0<9:0>				
6	00110	HS_clr _flt	0	0	0	HD_clr _flt	0	0	LD_cl r_flt	PD_clr _flt	LSD_c lr_flt	ld_oc	ld_op	ld_ot	vds_ld					vpre10	)<9:0>				
7	00111	0	0	Iclamp	didt	FDCL	LLC <1>	LLC <0>	CR_fb	CR_dis 12	CR_dis 34	х	CR_fb	CR_dis 12	CR_dis 34					vpre12	2<9:0>				
8	01000	0	0	0	0	0	0	0	0	0	0	lsd1_c r er	Isd2_c r er	Isd3_c r er	Isd4_c r er					vcp_vp	wr<9:0>				
9	01001	0	0	0	0	L	_PWM_	14	LI	F_PWM_	58	Х	Х	Х	Х					VINT_	A<9:0>				
10	01010			LSD1	duty cycl	e (8-bit) c	r current s	set point (	10-bit)			Isd1_o	lsd1_o p	lsd1_ot	vds_LS D1			LSD	1 duty cy	rcle (8bit)	or currer	nt read (1	0 bit)		
11	01011			LSD2	duty cycl	e (8-bit) c	r current s	set point (	10-bit)			Isd2_o	Isd2_o p	lsd2_ot	vds_LS D2			LSD	2 duty cy	rcle (8bit)	or currer	nt read (1	0 bit)		
12	01100			LSD3	duty cycl	e (8-bit) c	r current s	set point (	10-bit)			Isd3_ oc	Isd3_o p	lsd3_ot	vds_LS D3			LSD	3 duty cy	rcle (8bit)	or currer	nt read (1	0 bit)		
13	01101			LSD4	duty cycl	e (8-bit) c	r current s	set point (	10-bit)			Isd4_ oc	Isd4_o p	lsd4_ot	vds_LS D4			LSD	4 duty cy	rcle (8bit)	or currer	nt read (1	0 bit)		
14	01110				LSD5 di	uty cycle				0	0	lsd5_ oc	lsd5_o p	lsd5_ot	vds_LS D5				LSD5 di	uty cycle				0	0
15	01111				LSD6 de	uty cycle				0	0	Isd6_ oc	lsd6_o p	lsd6_ot	vds_LS D6				LSD6 di	uty cycle				0	0
16	10000				LSD7 d	uty cycle				0	0	Isd7_ oc	lsd7_o p	lsd7_ot	vds_LS D7	LS 7 LSD7 duty cycle 0					0				
17	10001				LSD8 de	uty cycle				0	0	Isd8_ oc	Isd8_o p	lsd8_ot	vds_LS D8	LS LSD8 duty cycle 0 0					0				
18	10010	0	0				MR<	7:0>				Х	Х	HD_lkg		ERR_CN	Т				AR<	<7:0>			
24	11000	0	0	0	0	0	0	0	0	0	0	HS_o c	HS_o p	HS_ot											
25	11001	0	0	0	0	0	0	0	0	0	0	Х	Х	Х	X ADIN2<9:0>										
26	11010	0	0	0	0	0	0	0	0	0	0	Х	Х	Х	X X ADIN3<9:0>										

#### Notes

22. MSB(B15) of both write and read messages is parity bit, whereas only B14 of read message is Fmsg, which show previous write message fault.

23. The 'X' bit is used for tests manufacturing.

## 6.10.3 SPI message description

## 6.10.3.1 Message #0

#### Table 25. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р			MSG_ID						SED	<7:0>				HPD_ sr	PD_mt_ cfg

Field	Bits		Description						
Р	15	Parity bit							
MSG_ID	14: 10	Message Identif	age Identifier: 00000						
SED<7:0>	09:02	SEED value of li	ED value of linear feedback shift register						
LIDD or	01	Bit = 0	HSD & PD slew rate selection is slow (default mode)						
HPD_sr	ΟΊ	Bit = 1	HSD & PD slew rate selection is fast						
DD mt ofa	00	Bit = 0	Overcurrent masking time is mt <sub>PD_OC1</sub> (default mode)						
PD_mt_cfg	00	Bit = 1	There is no Overcurrent masking time						

#### Table 26. Read message

B15	B14	B13	B12	B11	B10	В09	B08	B07	B06	B05	B04	B03	B02	B01	В00
Р	Fmsg		Vers	ion#		dosv_u v	Vcc_uv	Vint_uv	RST_cl k	RST_ ext	RST_ alu	RST_ wd	Х	HPD_ sr	PD_mt_ cfg

Field	Bits		Description
Р	15	Parity bit	
F	4.4	Bit = 0	Previous transfer was valid
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer
Version #	13: 10	Version num	ber is xxxx pass
daa	00	Bit = 0	DOSV continues normal voltage
dosv_uv	09	Bit = 1	DOSV was less than DOSV undervoltage threshold longer than tDVUV
Vcc5 uv	08	Bit = 0	VCC5 continues normal voltage
vcc5 uv	06	Bit = 1	VCC5 was less than VCC5_uv longer tVCUV
Vint uv	07	Bit = 0	Vint_D and Vint_A continues normal voltage
VIIII UV	07	Bit = 1	Vint_D or Vint_A voltage was low
DST all	06	Bit = 0	SB0800 internal clock is okay
RST_clk	00	Bit = 1	SB0800 internal clock fault was detected.
RST ext	05	Bit = 0	Normal
KS1_ext	05	Bit = 1	Reset from external (RSTB pin)
DST alu	04	Bit = 0	Normal
RST_alu	04	Bit = 1	Reset from monitoring module (ERR_CNT≥101)
DST wd	03	Bit = 0	Normal
RST_wd	03	Bit = 1	Valid MR wasn't updated within t_wd

Field	Bits		Description				
HPD_sr	01	Bit = x	Feedback internal HPD_sr register value				
PD_mt_cfg	00	Bit = x	it = x Feedback internal PD_mt_cfg register value				

## 6.10.3.2 Message #1

#### Table 27. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р			MSG_ID				P ch	arac			I charac		lsd_sink _dis	1	Х

Field	Bits		Description	
Р	15	Parity bit		
MSG_ID	14: 10	Message Ider	ntifier: 00001	
		BIT	P character	
		0111	Factor of P-characteristic = 1.2188	
		0110	Factor of P-characteristic = 1.1875	
		0101	Factor of P-characteristic = 1.1562	
		0100	Factor of P-characteristic = 1.125	
		0011	Factor of P-characteristic = 1.0938	
		0010	Factor of P-characteristic = 1.0625	
		0001	Factor of P-characteristic = 1.0312	
P charac	09: 06	0000	Factor of P-characteristic = 1	
		1000	Factor of P-characteristic = 1	
		1001	Factor of P-characteristic = 0.9688	
		1010	Factor of P-characteristic = 0.9375	
			1011	Factor of P-characteristic = 0.9062
			1100	Factor of P-characteristic = 0.875
		1101	Factor of P-characteristic = 0.8438	
		1110	Factor of P-characteristic = 0.8125	
		1111	Factor of P-characteristic = 0.7812	
		001	Factor of I-characteristic = 0.25	
		010	Factor of I-characteristic = 0.1875	
		011	Factor of I-characteristic = 0.1562	
I charac	05: 03	100	Factor of I-characteristic = 0.3125 (Imax)	
renarac	05.03	000	Factor of I-characteristic = 0.125 (default)	
		101	Factor of I-characteristic = 0.0938	
		110	Factor of I-characteristic = 0.0625	
		111	Factor of I-characteristic = 0.0312	
led eink die	02	Bit = 0	LSD sink current for open detection is enabled (default mode)	
lsd_sink_dis	02	Bit = 1	LSD sink current for open detection is disabled	

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### Table 28. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg		Manufacti	uring data	l		P ch	arac			I charac		lsd_sink _dis	Χ	Х

Field	Bits		Description		
Р	15	Parity bit			
		Bit = 0	Previous transfer was valid.		
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.		
Manufacturing data	13: 10	Could be used f	or traceability (same as version #)		
P charac	09: 06	Feedback of P	sharac		
I charac	05: 03	Feedback of I charac			
lsd_sink_dis	02	Feedback of lsd_sink_dis			

## 6.10.3.3 Message #2

Reserved

## 6.10.3.4 Message #3

### Table 29. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р			MSG_ID			Х	Х	Х	х	FM_am p	FM_EN	Stop CLK 2	Adin2_e n	Adin1_d is	OCF_p

Field	Bits		Description
Р	15	Parity bit	
MSG_ID	14:10	Message Id	lentifier: 00011
EM ann	٥٦	Bit = 0	Frequency modulation band 1
FM_amp	05	Bit = 1	Frequency modulation band 2
		Bit = 0	Frequency of Main/Aux oscillator clocks is fixed
FM_EN	04	Bit = 1	Frequency of Main/Aux oscillator clocks is modulated by the frequency defined by FM_amp
04011/0	00	Bit = 0	SB0800 internal clock monitoring function is enabled
StopCLK2	03	Bit = 1	SB0800 internal clock monitoring function is disabled
A 11: 0	00	Bit = 0	Allow to control the pump trough an output of the MCU
Adin2_en	02	Bit = 1	Allow to control the pump trough SPI command (LD_on bit)
A alter 4 alter	0.4	Bit = 0	Allow to control the low-side for resistive load trough SPI command (Pd_on bit)
Adin1_dis	01	Bit = 1	Allow to control the low-side for resistive load trough an output of the MCU
OCF_pd	00	Overcurren	t filter time of pump driver is selectable by OCF_pd

#### Table 30. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg		SB0800_CLK_CNT<7:0>							Vpwr ov	Х	Vpwr uv	FGND	OTW	Х

Field	Bits		Description				
Р	15	Parity bit					
F	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.				
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.				
SB0800_CLK_CNT<7:0>	13: 06	Monitoring re	esult from SB0800 internal clock(?)				
Maria	0.5	Bit = 0	Normal				
Vpwr_ov	05	Bit = 1	VPWR overvoltage				
Marine and	0.2	Bit = 0	Normal				
Vpwr_uv	03	Bit = 1	VPWR undervoltage				
FOND	00	Bit = 0	Normal				
FGND	02	Bit = 1	GND _D loss detection				
OTW av	0.1	Bit = 0	Normal				
OTW_ov	01	Bit = 1	Overtemperature warning				

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## 6.10.3.5 Message #4

### Table 31. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID				0	0	0	0	0	0	0	0	0	0	

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 00111

### Table 32. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg	0	Х	Х	Х					TEMP	9:0>				

Field	Bits		Description				
Р	15	Parity bit					
Emag	14	Bit = 0	Parity bit is correct. Previous transfer was valid.				
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.				
TEMP<9:0>	09:00	10-bit ADC of average die temperature					

## 6.10.3.6 Message #5

### Table 33. Write message

B15	B14	B13	B12	B11	B10	В09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID				0	0	0	0	pd_on	hd_on	0	0	HS_on	LD_on	

Field	Bits		Description						
Р	15	Parity bit							
MSG_ID	14: 10	Message Ide	lessage Identifier: 00101						
	٥٦	Bits = 0	Pump motor driver is off						
pd_on	05	Bits = 1	Pump motor driver is on						
hal an	0.4	Bits = 0	High-side driver is off						
hd_on	04	Bits = 1	High-side driver is on						
ID on	00	Bits = 0	Low-side is off						
LD_on	00	Bits = 1	Low-side turn on						

#### Table 34. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	В03	B02	B01	B00
Р	Fmsg	PD_oc	HD_oc	Х	Х					VINT_I	D<9:0>				

Field	Bits		Description			
Р	15	Parity bit				
Emag	14	Bit = 0	Parity bit is correct. Previous transfer was valid.			
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.			
DD	42	Bit = 0	Normal			
PD_oc	13	Bit = 1	Current regulation error detection of LSD1			
LID oo	12	Bit = 0	Normal			
HD_oc	12	Bit = 1	Current regulation error detection of LSD2			
VINT_D<9:0>	09:00	10-bit ADC internal supply				

## 6.10.3.7 Message #6

### Table 35. Write message

B1:	5	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р				MSG_ID			HS_clr_ flt	0	0	0	HD_clr_ flt	0	0	LD_clr_ flt	PD_clr_ flt	LSD_clr _flt

Field	Bits		Description
Р	15	Parity bit	
MSG_ID	14: 10	Message Identifier	: 00110
LIC ole fit	00	Bit = 0	HS_oc and HS_ot are conserved (default mode)
HS_clr_flt	09	Bit = 1	Clear HS_oc and HS_ot
LID als fit	٥٢	Bit = 0	HD_oc and HD_lkg are conserved (default mode)
HD_clr_flt	05	Bit = 1	Clear HD_oc and HD_lkg
I D. ala file	00	Bit = 0	LD_oc and LD_ot are conserved (default mode)
LD_clr_flt	02	Bit = 1	Clear LD_oc and LD_ot
	04	Bit = 0	PD_oc is conserved (default mode)
PD_clr_flt	01	Bit = 1	Clear PD_oc
LCD als file	00	Bit = 0	All LSDx_oc and LSDx_ot are conserved (default mode)
LSD_clr_flt	00	Bit = 1	Clear All LSDx_oc and LSDx_ot

### Table 36. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	В06	B05	B04	B03	B02	B01	B00
Р	Fmsg	ld_oc	ld_op	ld_ot	vds_ld					vpre10	)<9:0>				

Field	Bits		Description
Р	15	Parity bit	
F====	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.
ld ac	13	Bit = 0	Normal
ld_oc	13	Bit = 1	Overcurrent shut down of low-side
ld an	12	Bit = 0	Normal
ld_op	12	Bit = 1	Open load detection of low-side
ld at	44	Bit = 0	Normal
ld_ot	11	Bit = 1	Overtemperature shut down of low-side
اما ماما	40	Bit = 0	Normal
vds_ld	10	Bit = 1	Vds detection of low-side (information only)
vpre10<9:0>	09:00	10-bit ADC of	f vpre10

## 6.10.3.8 Message #7

### Table 37. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р			MSG_ID			0	0	Iclamp	didt	FDCL	LLC <1>	LLC <0>	CR_fb	CR_dis 12	CR_dis 34

Field	Bits	Description							
Р	15	Parity bit							
Iclamp	07	Bit = 0 Integrator limit	is 0x03FF						
ісіатір	07	Bit = 1 Integrator limit	is 0x07FF						
didt	06	Bit = 0 Rise / Fall time	of LSD is long (tr/tf_CR1)						
uut	00	Bit = 1 Rise / Fall time	of LSD is short (tr/tf_CR2)						
		Bit = 0 The first duty c	ycle is controlled by current						
FDCL	05		from off state to a target value is limited to a the duty cycle which a target current is transf						
		Bit = 00	The measurement is done at Ton/2						
		Bit = 01	Minimum duty cycle (DC) is 3.12% For DC > 10%, the measurement is done at Ton/2. For 3.12% < DC < 10%, the measurement is done at the maximum value between Ton and 3.12%						
LLC	04:03	Bit = 10  Minimum duty cycle (DC) is: 3.12% + 1.56% every two cycles For DC > 10%, the measurement is done at Ton/2.  Bit = 10  For 3.12% < DC < 10% the regulation current approach up to 3.12% of DC an measurement is done at the maximum value between Ton/2 and 3.12%  For 1.56% < DC < 3.12%, 3.12% of DC and 1.56%.  DC are forced every two cycles and no measurement is done during 1.56% of							
		Bit = 11	Minimum duty cycle (DC) is: 3.12% + skipping For DC > 10%, the measurement is done at For 3.12% < DC < 10% the regulation current measurement is done at the maximum value For DC < 3.12%, the regulation current force no measurement is done during the skipping	Ton/2.  nt approach up to 3.12% of DC and the between Ton/2 of DC and 3.12% as 3.12% and skipping every two cycles and					
CD th	02	Bit = 0	LSDx Feedback = SPI written value						
CR_fb	02	Bit = 1 LSDx Feedback = output							
			CR_fb = 0	CR_fb = 1					
CR_dis12	01	CR_dis12 = 0	LSD1,2 Current regulation	LSD1,2 Current regulation					
OI\_uis12		CR_dis12 = 1	LSD1,2 PWM	LSD1,2 PWM					
CR_dis34	00	CR_dis34 = 0 LSD3,4 Current regulation LSD3,4 Current regulatio							
OI\_uiso+	30	CR_dis34 = 1							

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#### Table 38. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg	Х	CR_fb	CR_dis 12	CR_dis 34					vpre12	2<9:0>				

Field	Bits		Description					
Р	15	Parity bit						
Гтая	1.1	Bit = 0	Parity bit is correct. Previous transfer was valid.					
Fmsg	14	Bit = 1	= 1 Parity bit is not correct. Error detected during previous transfer.					
CR_fb	12	Feedback o	eedback of CR_fb					
CR_dis12		Feedback o	f CR_dis12					
CR_dis34		Feedback o	eedback of CR_dis34					
vpre12<9:0>	09:00	10-bit ADC of vpre12						

## 6.10.3.9 Message #8

#### Table 39. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р		MSG_ID				0	0	0	0	0	0	0	0	0	0

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 01000

#### Table 40. Read message

B15	B14	B13	B12	B11	B10	В09	B08	B07	В06	B05	B04	B03	B02	B01	B00
Р	Fmsg	lsd1_cr er	lsd2_cr er	lsd3_cr er	lsd4_cr er					vcp_vp	wr<9:0>				

Field	Bits		Description		
Р	15	Parity bit			
Г	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.		
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.		
ladd aren	40	Bit = 0	Normal		
lsd1_crer	13	Bit = 1	Current regulation error detection of LSD1		
ladO aran	40	Bit = 0	Normal		
lsd2_crer	12	Bit = 1	Current regulation error detection of LSD2		
1- 10	44	Bit = 0	Normal		
lsd3_crer	11	Bit = 1	Current regulation error detection of LSD3		
ladd avan	40	Bit = 0	Normal		
lsd4_crer	10	Bit = 1	Current regulation error detection of LSD4		
vcp_vpwr<9:0>	09:00	10-bit ADC of vcp_vpwr			

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## 6.10.3.10 Message #9

### Table 41. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р		MSG_ID				Х	Х	Х	Х	LI	F_PWM_	14	LF	PWM_5	58

Field	Bits		Description
Р	15	Parity bit	
MSG_ID	14: 10	Message Iden	tifier: 01001
		Bit = 000	Output PWM frequency of LSD(1~4)= 3.9 kHz
		Bit = 001	Output PWM frequency of LSD(1~4)= 4.5 kHz
		Bit = 010	Output PWM frequency of LSD(1~4)= 5.0 kHz
L	05.00	Bit = 011	Output PWM frequency of LSD(1~4)= 4.2 kHz
LF_PWM_14	05:03	Bit = 100	Output PWM frequency of LSD(1~4)= 3.6 kHz
		Bit = 101	Output PWM frequency of LSD(1~4)= 3.4 kHz
		Bit = 110	Output PWM frequency of LSD(1~4)= 3.2 kHz
		Bit = 111	Output PWM frequency of LSD(1~4)= 3.0 kHz
		Bit = 000	Output PWM frequency of LSD(5~8)= 3.9 kHz
		Bit = 001	Output PWM frequency of LSD(5~8)= 4.5 kHz
		Bit = 010	Output PWM frequency of LSD(5~8)= 5.0 kHz
LE DIAMA 50	00.00	Bit = 011	Output PWM frequency of LSD(5~8)= 4.2 kHz
LF_PWM_58	02:00	Bit = 100	Output PWM frequency of LSD(5~8)= 3.6 kHz
		Bit = 101	Output PWM frequency of LSD(5~8)= 3.4 kHz
		Bit = 110	Output PWM frequency of LSD(5~8)= 3.2 kHz
		Bit = 111	Output PWM frequency of LSD(5~8)= 3.0 kHz

### Table 42. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg									VINT_	A<9:0>				

Field	Bits		Description
Р	15	Parity bit	
Emag	14	Bit = 0	Parity bit is correct. Previous transfer was valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.
VINT_A<9:0>	09:00	10-bit ADC	of internal supply

## 6.10.3.11 Message #10

### Table 43. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р		MSC	G_ID					LSD1	duty cycle	e (8-bit) o	r current s	set point (	10-bit)		

Field	Bits		Description	
Р	15	Parity bit		
MSG_ID	14: 10	Message Identifier: 01	010	
			CR_fb=0	CR_fb=1
LSD1 duty cycle (8-bit) or	09:00	CR_dis12= 0	LSD1, 2 current regulation Write current target (10 bits, 0 to 2.25 A)	LSD1,2 current regulation Write current target (10 bits, 0 to 2.25 A)
current set point(10-bit)		CR_dis12= 1	LSD1, 2 PWM Write programmed duty cycle (8 bits at 0%, 100% and 10% to 90%) LSD1[1:0]=XX	LSD1,2 PWM Write programmed duty cycle (8 bits at 0%, 100% and 10% to 90%) LSD1[1:0]=XX

#### Table 44. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	В03	B02	B01	B00
Р	Fmsg	lsd1_ oc	lsd1_op	lsd1_ot	vds_ LSD1			LSD	1 duty cy	cle (8-bit)	or curren	nt read (10	)-bit)		

Field	Bits		Description			
Р	15	Parity bit				
F	44	Bit = 0	Parity bit is correct. Previous transfer wa	s valid.		
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected du	uring previous transfer.		
1.14	40	Bit = 0	Normal			
lsd1_ oc	13	Bit = 1	Overcurrent shutdown of LSD1			
		Bit = 0	Normal			
lsd1_op	12	Bit = 1	Open Load detection of LSD1			
		Bit = 0	Normal			
lsd1_ot	11	Bit = 1	Overtemperature shutdown of LSD1			
		Bit = 0	Normal			
vds_LSD1	10	Bit = 1	V <sub>DS</sub> detection of LSD1 (information only)	)		
			CR_fb=0	CR_fb=1		
LSD1 duty cycle (8-bit) or	09:00	CR_dis12= 0	LSD1,2 current regulation Read current target (to check SPI write) (10 bits, 0 to 2.25 A)	LSD1,2 current regulation Output duty cycle value for gate driver (8 bits, for the range to 100%)		
current read (10-bit)		CR_dis12= 1	LSD1,2 PWM Read programmed PWM duty cycle (to check SPI write) (8 bits at 0%, 100% and 10% to 90%) LSD(1~2)[1:0]=00  LSD1,2 PWM Read hardware ADC current value (10 bits for the range to 4.5A)			

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## 6.10.3.12 Message #11

### Table 45. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р			MSG_ID					LSD2	duty cycl	e (8bit) or	current s	et point (1	IO-bit)		

Field	Bits		Description	
Р	15	Parity bit		
MSG_ID	14: 10	Message Identifier: 07	1011	
			CR_fb=0	CR_fb=1
LSD2 duty cycle (8-bit) or	09:00	CR_dis12= 0	LSD1,2 current regulation Write current target (10 bits, 0 to 2.25 A)	LSD1,2 current regulation Write current target (10 bits, 0 to 2.25 A)
current set point(10-bit)	22100	CR_dis12= 1	LSD1,2 PWM Write programmed duty cycle (8 bits at 0%, 100% and 10% to 90%) LSD2[1:0]=XX	LSD1,2 PWM Write programmed duty cycle (8 bits at 0%, 100% and 10% to 90%) LSD2[1:0]=XX

#### Table 46. Read message

B15	B14	B13	B12	B11	B10	В09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg	lsd2_ oc	lsd2_op	lsd2_ot	vds_LS D2			LSD	2 duty cy	cle (8-bit)	or curren	t read (10	)-bit)		

Field	Bits		Description	
Р	15	Parity bit		
Fare	4.4	Bit = 0	Parity bit is correct. Previous transfer was	valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected dur	ing previous transfer.
1-10	40	Bit = 0	Normal	
lsd2_ oc	13	Bit = 1	Overcurrent shutdown of LSD2	
110	40	Bit = 0	Normal	
lsd2_op	12	Bit = 1	Open load detection of LSD2	
ladO at	44	Bit = 0	Normal	
lsd2_ot	11	Bit = 1	Overtemperature shutdown of LSD2	
l. 1 0D0	40	Bit = 0	Normal	
vds_LSD2	10	Bit = 1	V <sub>DS</sub> detection of LSD2 (information only)	
			CR_fb = 0	CR_fb=1
LSD2 duty cycle (8-bit) or	09:00	CR_dis12= 0	LSD1,2 current regulation Read current target (to check SPI write) (10 bits, 0 to 2.25 A)	LSD1,2 current regulation Output duty cycle value for gate driver (8 bits, for the range to 100%)
current read (10-bit)		CR_dis12= 1	LSD1,2 PWM Read programmed PWM duty cycle (to check SPI write) (8 bits at 0%, 100% and 10% to 90%) LSD(1~2)[1:0]=00	LSD1,2 PWM Read hardware ADC current value (10 bits for the range to 4.5 A)

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## 6.10.3.13 Message #12

#### Table 47. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р		MSG_ID						LSD3	duty cycle	e (8-bit) o	r current s	set point (	10-bit)		

Field	Bits		Description	on
Р	15	Parity bit		
MSG_ID	14: 10	Message Identifier: 0	1100	
			CR_fb=0	CR_fb=1
LSD3 duty cycle (8-bit) or	00.00	CR_dis34= 0	LSD3,4 current regulation Write current target (10 bits, 0 to 2.25 A)	LSD3,4 current regulation Write current target (10 bits, 0 to 2.25 A)
current set point(10-bit)	09:00	CR_dis34= 1	LSD3,4 PWM Write programmed duty cycle (8 bits at 0%, 100% and 10% to 90%) LSD3[1:0]=XX	LSD3,4 PWM Write programmed duty cycle (8 bits at 0%, 100% and 10% to 90%) LSD3[1:0]=XX

#### Table 48. Read message

	B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
1	Р	Fmsg	lsd3_ oc	lsd3_op	lsd3_ot	vds_LS D3			LSD	3 duty cy	cle (8-bit)	or curren	it read (10	)-bit)		

Field	Bits		Description					
Р	15	Parity bit						
F	4.4	Bit = 0	Parity bit is correct. Previous transfer v	vas valid.				
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected	during previous transfer.				
lad2 aa	42	Bit = 0	Normal					
lsd3_ oc	13	Bit = 1	Overcurrent shutdown of LSD3					
lad2 an	12	Bit = 0	Normal					
lsd3_op	12	Bit = 1	Open load detection of LSD3					
lad2 at	4.4	Bit = 0	Normal					
1803_01	lsd3_ot 11		Overtemperature shutdown of LSD3					
udo I CD2	10	Bit = 0	Normal					
vds_LSD3	10	Bit = 1	V <sub>DS</sub> detection of LSD3 (information on	ly)				
			CR_fb=0	CR_fb=1				
LSD3 duty cycle (8-bit) or	09:00	CR_dis34= 0	LSD3,4 current regulation Read current target (to check SPI write) (10 bits, 0 to 2.25 A)	LSD3,4 current regulation Output duty cycle value for gate driver (8 bits, for the range to 100%)				
current read (10-bit)		CR_dis34= 1	LSD3,4 PWM Read programmed PWM duty cycle (to check SPI write) (8 bits at 0%, 100% and 10% to 90%) LSD(3~4)[1:0]=00	LSD3,4 PWM Read hardware ADC current value (10 bits for the range to 4.5 A)				

## 6.10.3.14 Message #13

### Table 49. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID							LSD4	duty cycle	e (8-bit) o	r current s	et point (	10-bit)		

Field	Bits		Descriptio	n
Р	15	Parity bit		
MSG_ID	14: 10	Message Identifie	er: 01101	
			CR_fb=0	CR_fb=1
LSD4 duty cycle (8-bit) or	09:00	CR_dis34= 0	LSD3, 4 current regulation Write current target (10 bits for the range to 2.25 A)	LSD3, 4 current regulation Write current target (10 bits for the range to 2.25 A)
current set point (10-bit)	33.00	CR_dis34= 1	LSD3,4 PWM Write programmed duty cycle (8 bits for the range to 100%) LSD4[1:0]=XX	LSD3, 4 PWM Write programmed duty cycle (8 bits for the range to 100%) LSD4[1:0]=XX

#### Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg	lsd4_ oc	lsd4_op	lsd4_ot	vds_LS D4			LSE	4 duty cy	cle (8-bit)	or curren	t read (10	-bit)		

Field	Bits		Description					
Р	15	Parity bit						
<b>5</b>	4.4	Bit = 0	Parity bit is correct. Previous transfer was	valid.				
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected dur	ring previous transfer.				
		Bit = 0	Normal					
lsd4_ oc	13	Bit = 1	Overcurrent shutdown of LSD4					
		Bit = 0	Normal					
lsd4_op	12	Bit = 1	Open load detection of LSD4					
		Bit = 0	Normal					
lsd4_ot	11	Bit = 1	Overtemperature shutdown of LSD4					
		Bit = 0	Normal					
vds_LSD4	10	Bit = 1	V <sub>DS</sub> detection of LSD4 (information only)					
			CR_fb=0	CR_fb=1				
LSD4 duty cycle (8-bit) or	09:00	CR_dis34= 0	LSD3,4 current regulation Read current target (to check SPI write) (10 bits, 0 to 2.25 A)	LSD3,4 current regulation Output duty cycle value for gate driver (8 bits, for the range to 100%)				
current read (10-bit)	55.55	CR_dis34= 1	LSD3,4 PWM Read programmed PWM duty cycle (to check SPI write) (8 bits at 0%, 100% and 10% to 90%) LSD(3~4)[1:0]=00	LSD3,4 PWM Read hardware ADC current value (10 bits for the range to 4.5 A)				

## 6.10.3.15 Message #14

#### Table 50. Write message

B15	B14	B13	B12	B11	B10	В09	B08	B07	B06	B05	B04	B03	B02	B01	B00	
Р		MSG_ID						L	SD5 duty	cycle (8b	it)			Х	Х	

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 01110
LSD5 duty cycle	09:02	LSD5 PWM duty cycle

### Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg	lsd5_oc	lsd5_op	lsd5_ot	vds_ LSD5			L	SD5 duty	cycle (8b	it)			Χ	Х

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Field	Bits		Description			
Р	15	Parity bit				
F	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.			
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.			
ladE as	42	Bit = 0	Normal			
lsd5_ oc	13	Bit = 1	Overcurrent shutdown of LSD5			
ladE an	40	Bit = 0	Normal			
lsd5_op	12	Bit = 1	Open load detection of LSD5			
ladE at	11	Bit = 0	Normal			
lsd5_ot	11	Bit = 1	Overtemperature shutdown of LSD5			
uda LODE	40	Bit = 0	Normal			
vds_LSD5	10	Bit = 1	V <sub>DS</sub> detection of LSD5 (information only)			
LSD5 duty cycle (8-bit) 09:02		Read Programmed PWM duty cycle (to check SPI write) (8 bits for the range to 100%)				

## 6.10.3.16 Message #15

### Table 51. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	В00
Р	MSG_ID							L	SD6 duty	cycle (8b	it)			Х	Х

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 01111
LSD6 duty cycle	09:02	LSD6 PWM duty cycle

#### Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	В00
Р	Fmsg	lsd6_oc	lsd6_op	lsd6_ot	vds_ LSD6			L	SD6 duty	cycle (8b	it)			Х	Х

Field	Bits		Description
Р	15	Parity bit	
F	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.
110	40	Bit = 0	Normal
lsd6_ oc	13	Bit = 1	Overcurrent shutdown of LSD6
ladC an	40	Bit = 0	Normal
lsd6_op	12	Bit = 1	Open load detection of LSD6
ladO at	44	Bit = 0	Normal
lsd6_ot	11	Bit = 1	Overtemperature shutdown of LSD6
uda LCDC	40	Bit = 0	Normal
vds_LSD6	10	Bit = 1	V <sub>DS</sub> detection of LSD6 (information only)
LSD6 duty cycle (8-bit)	Read Programmed PWM duty cycle (to check SPI write) (8 bits for the range to 100%)		· · · · · · · · · · · · · · · · · · ·

## 6.10.3.17 Message #16

### Table 52. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	В00
Р		MSG_ID						L	SD7 duty	cycle (8b	it)			Х	Х

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 10000
LSD7 duty cycle	09:02	LSD7 PWM duty cycle

#### Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	В00
Р	Fmsg	lsd7_oc	lsd7_op	lsd7_ot	vds_ LSD7			L	SD7 duty	cycle (8b	it)			Х	Х

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Field	Bits		Description
Р	15	Parity bit	
F	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.
lad7 as	13	Bit = 0	Normal
lsd7_ oc		Bit = 1	Overcurrent shutdown of LSD7
lad7 an		Bit = 0	Normal
lsd7_op	12	Bit = 1	Open load detection of LSD7
1047 04	44	Bit = 0	Normal
lsd7_ot	11	Bit = 1	Overtemperature shutdown of LSD7
da 1007	40	Bit = 0	Normal
vds_LSD7	10	Bit = 1	V <sub>DS</sub> detection of LSD7 (information only)
LSD7 duty cycle (8-bit) 09:02		Read Programme (8 bits for the rang	d PWM duty cycle (to check SPI write) le to 100%)

## 6.10.3.18 Message #17

### Table 53. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID							L	SD8 duty	cycle (8b	it)			Х	Х

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 10001
LSD8 duty cycle	09:02	LSD8 PWM duty cycle

### Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	В06	B05	B04	B03	B02	B01	B00
Р	Fmsg	lsd8_oc	lsd8_op	lsd8_ot	vds_ LSD8			L	SD7 duty	cycle (8b	it)			Х	Х

Field	Bits		Description
Р	15	Parity bit	
F	4.4	Bit = 0	Parity bit is correct. Previous transfer was valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.
lad0 as	13	Bit = 0	Normal
lsd8_ oc	13	Bit = 1	Overcurrent shutdown of LSD8
15.40	12	Bit = 0	Normal
lsd8_op	12	Bit = 1	Open load detection of LSD8
lad0 at	11	Bit = 0	Normal
lsd8_ot	11	Bit = 1	Overtemperature shutdown of LSD7
	40	Bit = 0	Normal
vds_LSD8	10	Bit = 1	V <sub>DS</sub> detection of LSD8 (information only)
LSD8 duty cycle (8-bit)	09:02	_	mmed PWM duty cycle (to check SPI write) range to 100%)

## 6.10.3.19 Message #18

### Table 54. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID					Х	Х				MR<	÷7:0>			

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 10010
MR<7:0>	07:00	Monitoring result of MCU

### Table 55. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	В00
Р	Fmsg	Х	Х	Х	HD_lkg	!	ERR_CN1	Γ				AR<7:0>			

Field	Bits		Description					
Р	15	Parity bit						
Fmsg	14	Bit = 0	Parity bit is correct. Previous transfer was valid.					
LID. II	4.4	Bit = 0	Normal					
HD_lkg	11	Bit = 1	High-side driver leakage detected					
ERR_CNT	10:08	3 bit error cou	oit error counter value of monitoring logic					
AR<7:0>	07:00	Monitoring result of SB0800						

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## 6.10.3.20 Message #19 to 23

Reserved

### 6.10.3.21 Message #24

#### Table 56. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р		MSG_ID					0	0	0	0	0	0	0	0	0

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 11000

#### Table 57. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg	HS_oc	HS_op	HS_ot	vds_HS					AD_RS	T1<9:0>				

Field	Bits		Description
Р	15	Parity bit	
Emag	14	Bit = 0	Parity bit is correct. Previous transfer was valid.
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.
115.00	13	Bit = 0	Normal
HS_oc	13	Bit = 1	Overcurrent shut down of high-side
LIC on	12	Bit = 0	Normal
HS_op		Bit = 1	Open load detection of high-side
HS_ot	11	Bit = 0	Normal
ПЭ_01	''	Bit = 1	Overtemperature shut down of high-side
udo IIC	10	Bit = 0	Normal
vds_HS	10	Bit = 1	Vds detection of high-side (information only)
AD_RST1<9:0>	09:00	10-bit ADC o	of ADIN1

### 6.10.3.22 Message #25

#### Table 58. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID					0	0	0	0	0	0	0	0	0	0

Field Bits	Description
------------	-------------

Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 11001

### Table 59. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	В03	B02	B01	B00
Р	Fmsg					AD_RST2<9:0>									

Field	Bits	Description			
Р	15	Parity bit			
Emag	14	Bit = 0	Parity bit is correct. Previous transfer was valid.		
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.		
AD_RST2<9:0>	09:00	10-bit ADC of	ADIN2		

## 6.10.3.23 Message #26

#### Table 60. Write message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	MSG_ID			Х	Х	Х	Х	Х	Х	Х	Х	Х	Х		

Field	Bits	Description
Р	15	Parity bit
MSG_ID	14: 10	Message Identifier: 11010

### Table 61. Read message

B15	B14	B13	B12	B11	B10	B09	B08	B07	B06	B05	B04	B03	B02	B01	B00
Р	Fmsg					AD_RST3<9:0>									

Field	Bits		Description			
Р	15	Parity bit				
- Fmag	14	Bit = 0	Parity bit is correct. Previous transfer was valid.			
Fmsg	14	Bit = 1	Parity bit is not correct. Error detected during previous transfer.			
AD_RST3<9:0>	09:00	10-bit ADC of	FADIN3			

SB0800

## 7 Typical applications

## 7.1 Application diagrams

This section presents a typical Industrial applications schematic using SB0800, as shown in Figure 20.

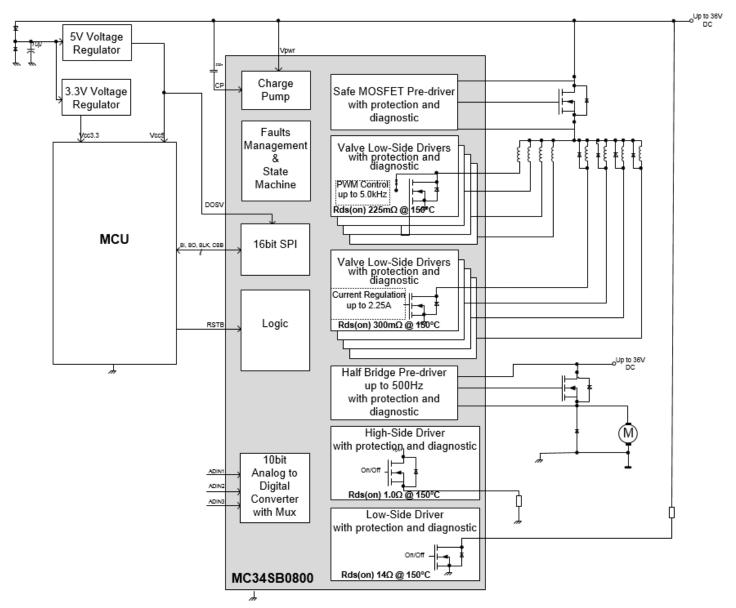


Figure 20. Industrial valves and pump control unit simplified diagram

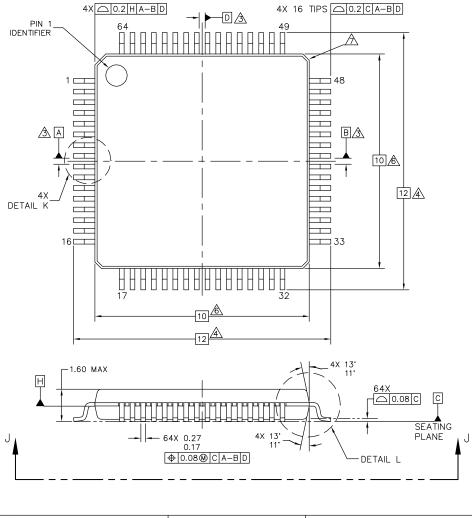
# 8 Packaging

## 8.1 Package mechanical dimensions

Package dimensions are provided in package drawings. To find the most current package outline drawing, go to www.nxp.com and perform a keyword search for the drawing's document number.

Package	Suffix	Package outline drawing number
10 x 10, 64-Pin LQFP Exposed Pad, with 0.5 mm pitch, and a 6.1 x 6.1 exposed pad	AE	98ASA10763D

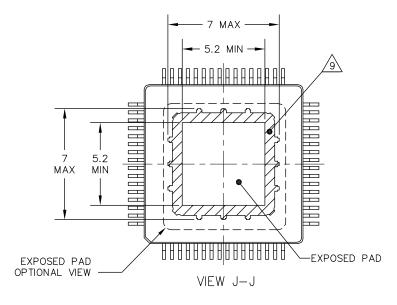


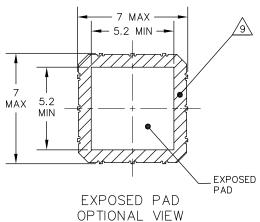


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TITLE: LQFP, 10 X 10 X	1.4 PKG,	DOCUMEN	NT NO: 98ASA10763D	REV: B
,	0.5 PITCH, 64LD,			
6.1 x 6.1 EXPOS	STANDAF	RD: JEDEC MS-026 BC	CD	

SB0800

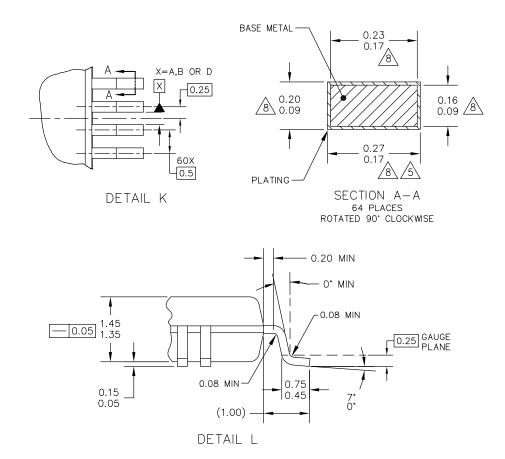






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TITLE: LQFP, 10 X 10 X	1.4 PKG,	DOCUMEN	NT NO: 98ASA10763D	REV: B
0.5 PITCH, 6	4LD,	CASE NUMBER: 1899-03 20 SEP 2012		
6.1 x 6.1 EXPOS	SED PAD	STANDAF	RD: JEDEC MS-026 BC	CD





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TITLE: LQFP, 10 X 10 X	1.4 PKG,	DOCUMEN	NT NO: 98ASA10763D	REV: B
0.5 PITCH, 6	′	CASE NUMBER: 1899-03 20 SEP 201		
6.1 x 6.1 EXPOS	SED PAD	STANDAF	RD: JEDEC MS-026 BC	CD



#### NOTES:

- 1. DIMENSIONS ARE IN MILLIMETERS.
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- A DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.
- DIMENSIONS TO BE DETERMINED AT SEATING PLANE C.
- DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE MAXIMUM DIMENSION BY MORE THAN 0.08 MM. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD OR PROTRUSION 0.07 MM.
- DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25 MM PER SIDE. DIMENSIONS ARE MAXIMUM PLASTIC BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH.
- A EXACT SHAPE OF EACH CORNER IS OPTIONAL.
- THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 MM AND 0.25 MM FROM THE LEAD TIP.
- A HATCHED AREA TO BE KEEP OUT ZONE FOR PCB ROUTING.

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TITLE: LQFP, 10 X 10 X	1.4 PKG,	DOCUMEN	NT ND: 98ASA10763D	REV: B
0.5 PITCH, 6	CASE NUMBER: 1899-03 20 SEP 201			
6.1 x 6.1 EXPOS	STANDARD: JEDEC MS-026 BCD			

# 9 Revision history

Revision	Date	Description of changes
1.0	5/2014	Initial release
	11/2014	Increased the operating voltage of the device to 36 V     Updated the parameters with new operating value
2.0 4/2015		Changed doc classification from Product Preview to Advance Information     Corrected form and style
	5/2015	Updated document title
3.0	5/2015	Added t <sub>VAM</sub> to <u>Table 20</u> Added <u>Figure 16</u>
	8/2016	Updated document to NXP form and style



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